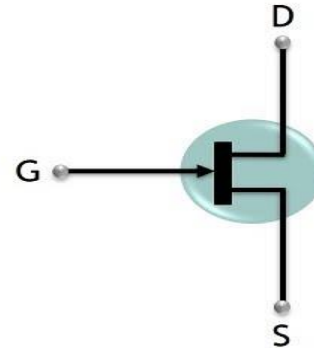
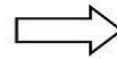
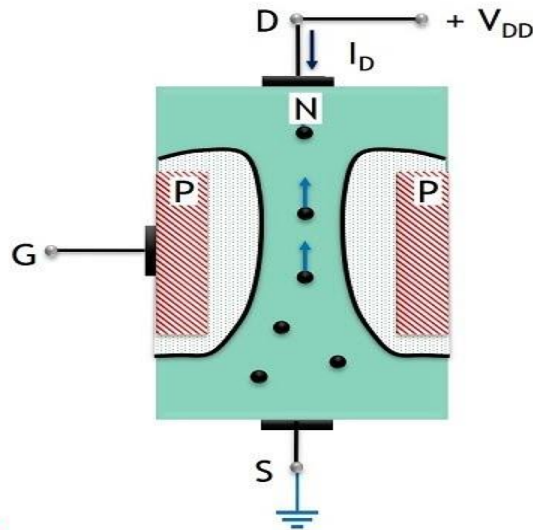


# What is **JFET** ?

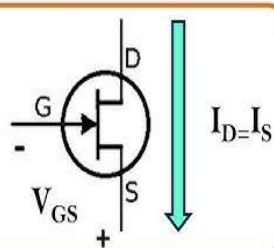
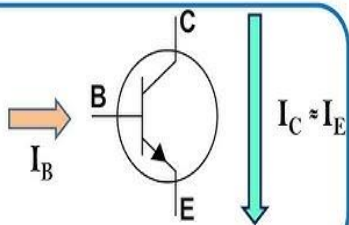
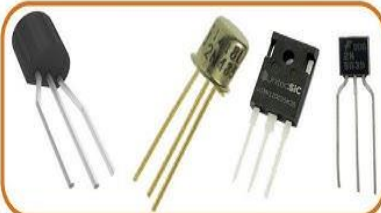


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Circuit Globe

BJT Transistor

JFET Transistor



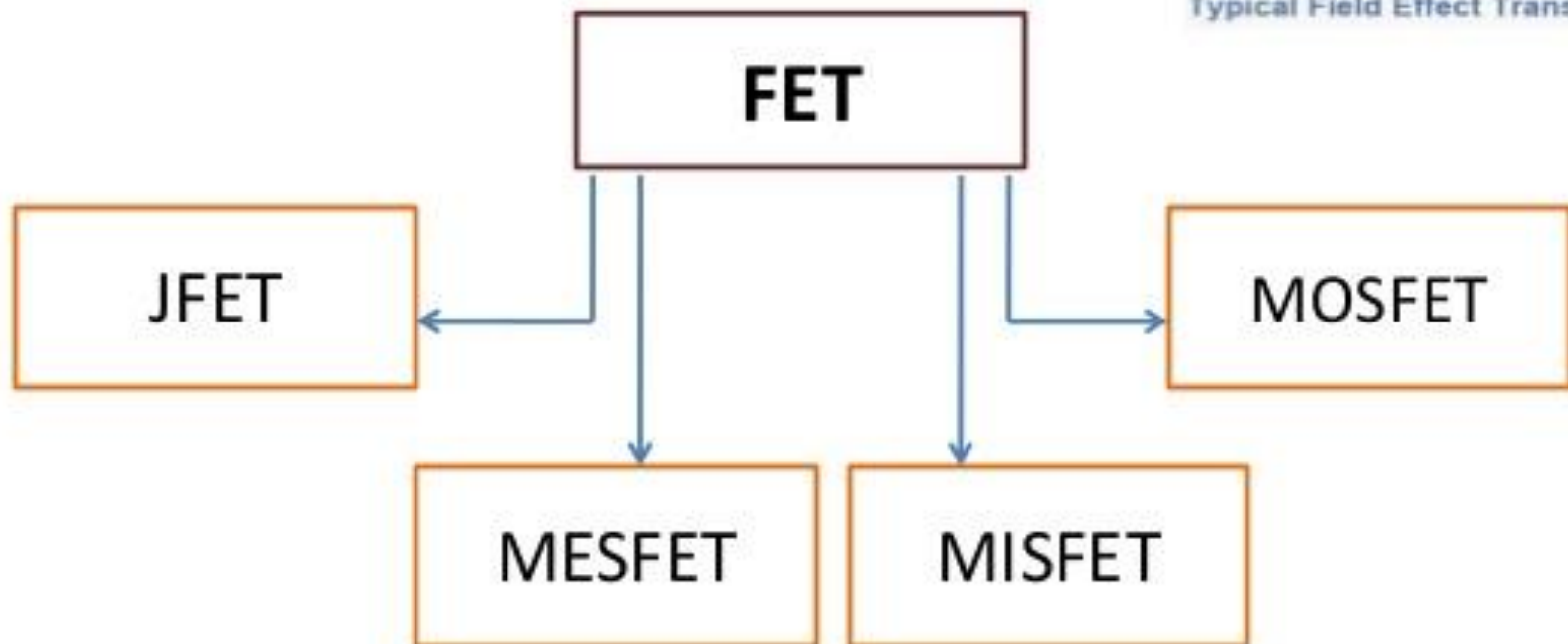
**Ms. R.GOWTHAR**  
**ASSISTANT PROFESSOR**  
**DEPARTMENT OF PHYSICS**  
**JAMAL MOHAMED COLLEGE**  
**TRICHY 20**

# Field Effect Transistor

Field effect Transistor is a semiconductor device which depends for its operation on the control of current by an electric Field

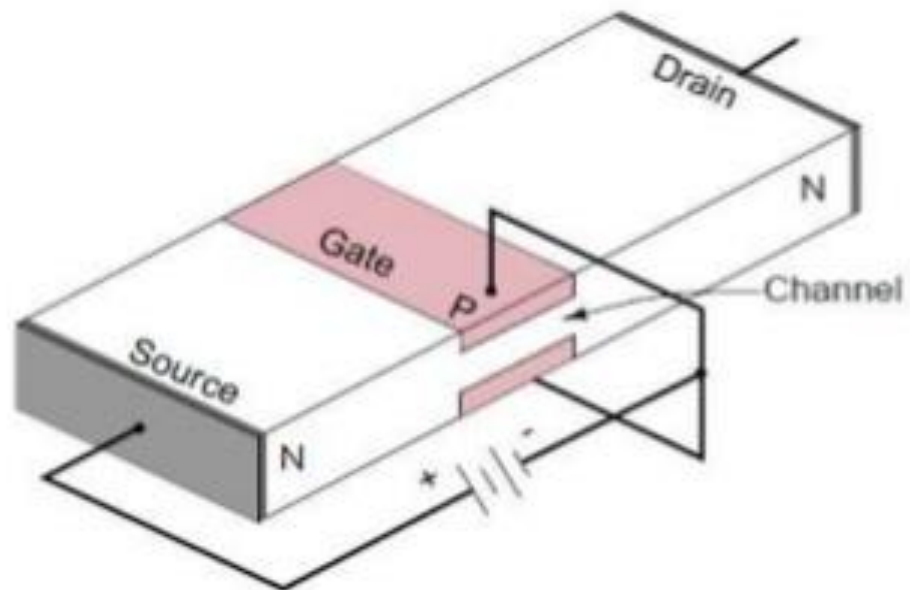
# Field Effect Transistor (FET)

- FET is a voltage controlled device.
- It consists of three terminal .
  - Gate
  - Source
  - Drain
- It is classified as four types.



# Junction Field Effect Transistor (JFET)

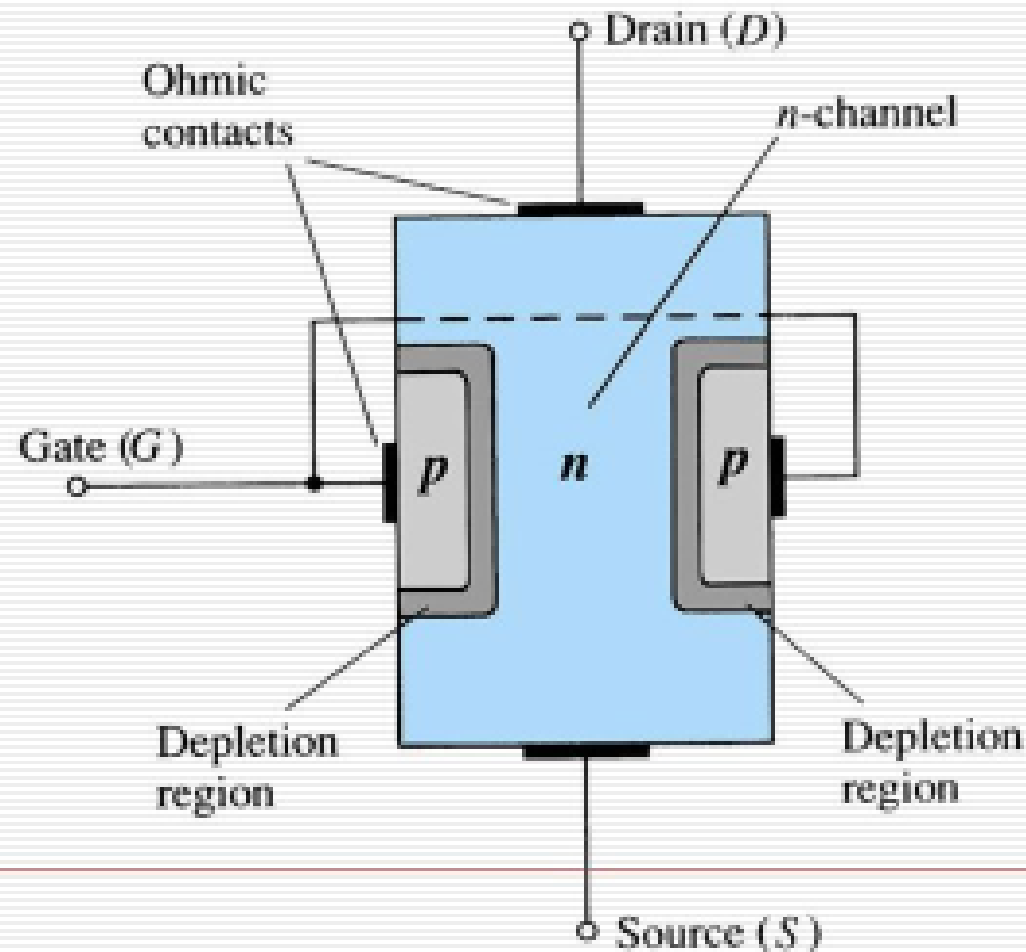
□ **Junction Field Effect Transistor** is a three terminal semiconductor device in which current conducted by one type of carrier i.e. by electron or hole.



*Junction field effect transistor*

# Junction field-effect transistor (JFET)

---



## FET and BJT

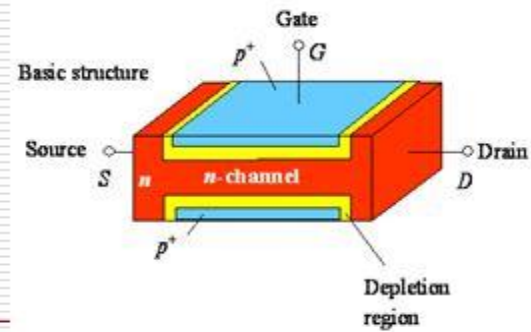
### FET

1. Uni polar device
2. Voltage controlled Device
3. High input impedance (in Mega ohms)
4. Better thermal stability
5. High switching speeds
6. Less Noisy
7. Easy to fabricate

### BJT

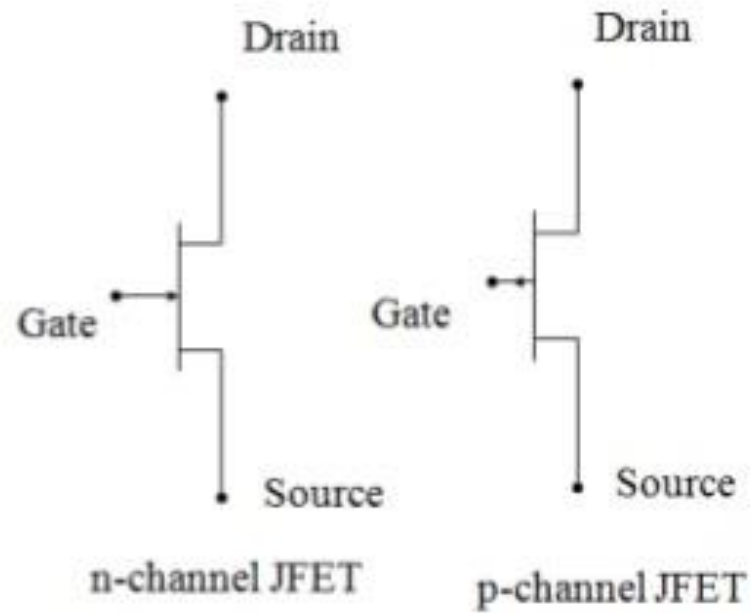
1. Bipolar device
2. Current controlled device
3. Low input impedance
4. Low thermal stability
5. Lower switching speeds
6. More noisy
7. Diffuicult to fabricate on IC

# Junction FETs



- ❑ JFET is a high-input resistance device, while the BJT is comparatively low.
- ❑ If the channel is doped with a **donor impurity**, n-type material is formed and the channel current will consist of electrons.
- ❑ If the channel is doped with an **acceptor impurity**, p-type material will be formed and the channel current will consist of holes.
- ❑ N-channel devices have greater conductivity than p-channel types, since electrons have higher mobility than do holes; **thus n-channel JFETs are approximately twice as efficient conductors compared to their p-channel counterparts.**

# Symbol of JFET





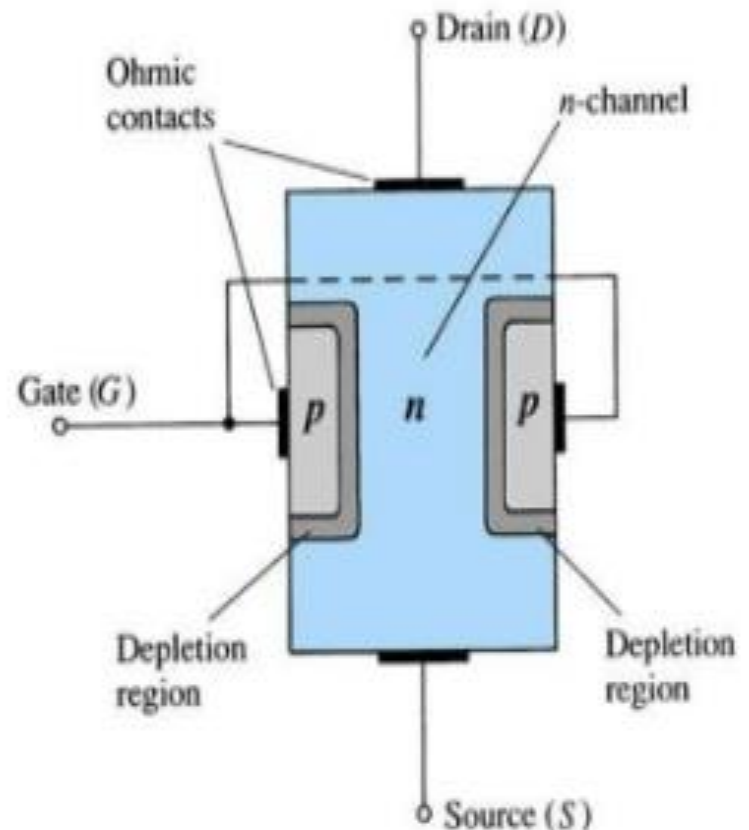
## Construction of JFET

❑ **Source:** The terminal through which the majority carriers enter into the channel, is called the *source* terminal S .

❑ **Drain:** The terminal, through which the majority carriers leave from the channel, is called the *drain* terminal D .

❑ **Gate:** There are two internally connected heavily doped impurity regions to create two P-N junctions. These impurity regions are called the *gate* terminal G.

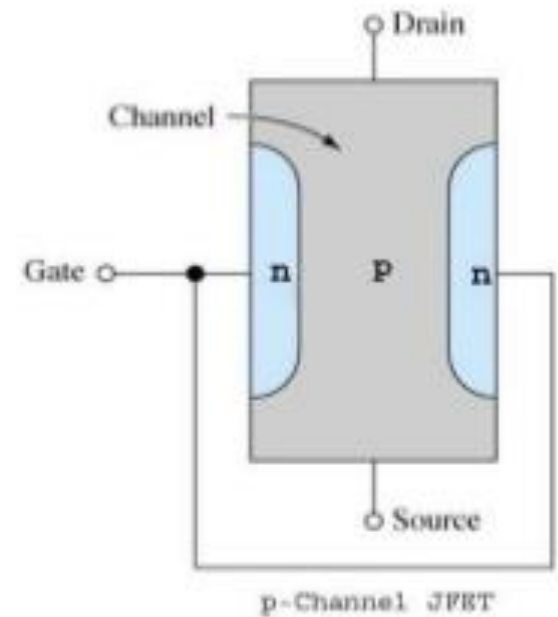
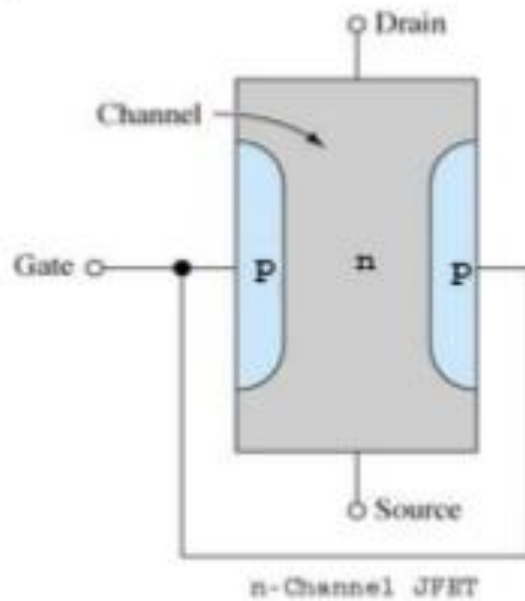
❑ **Channel:** The region between the source and drain, sandwiched between the two gates is called the *channel* .



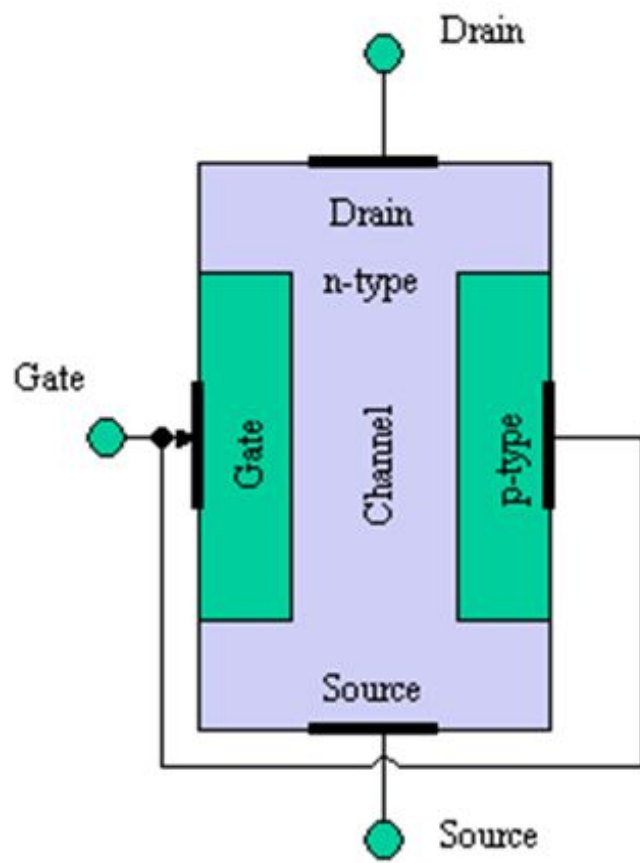
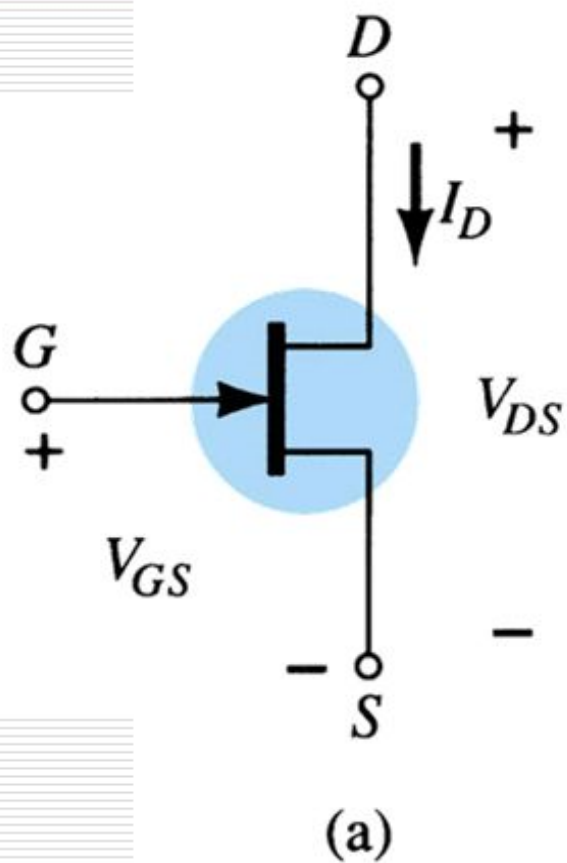
# Types of JFET

➤ JFET has two types :

- n- Channel JFET
- p- Channel JFET



# N-channel JFET..



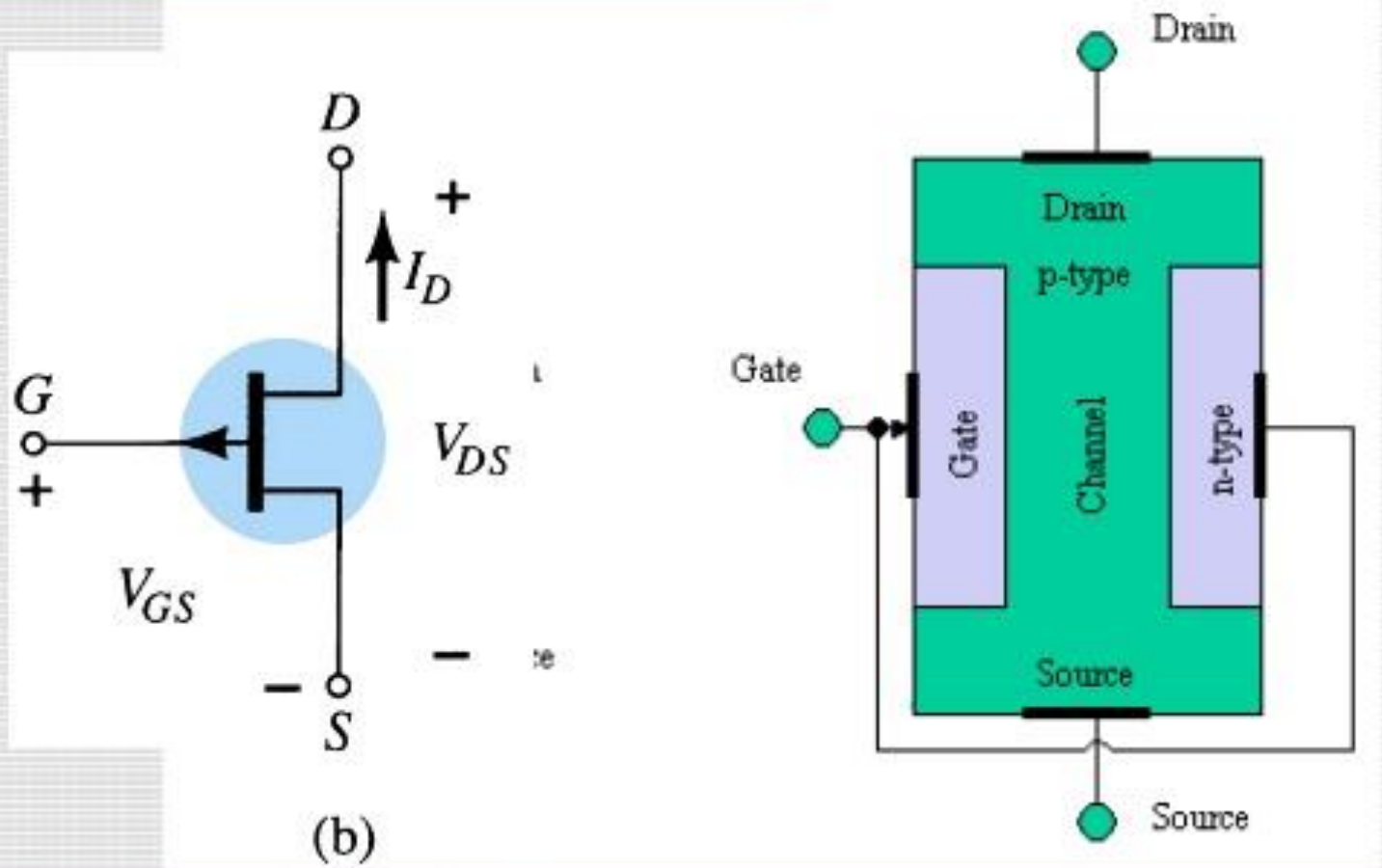
# N-channel JFET

---

## □ N channel JFET:

- Major structure is **n-type material (channel)** between embedded **p-type material** to form 2 p-n junction.
  - In the normal operation of an n-channel device, the **Drain (D)** is positive with respect to the **Source (S)**. Current flows into the Drain (D), through the channel, and out of the Source (S)
  - Because the resistance of the channel depends on the **gate-to-source voltage ( $V_{GS}$ )**, the **drain current ( $I_D$ )** is controlled by that voltage
-

# P-channel JFET..



# P-channel JFET

---

## □ P channel JFET:

- Major structure is p-type material (channel) between embedded n-type material to form 2 p-n junction.
  - Current flow : from Source (S) to Drain (D)
  - Holes injected to Source (S) through p-type channel and flowed to Drain (D)
-

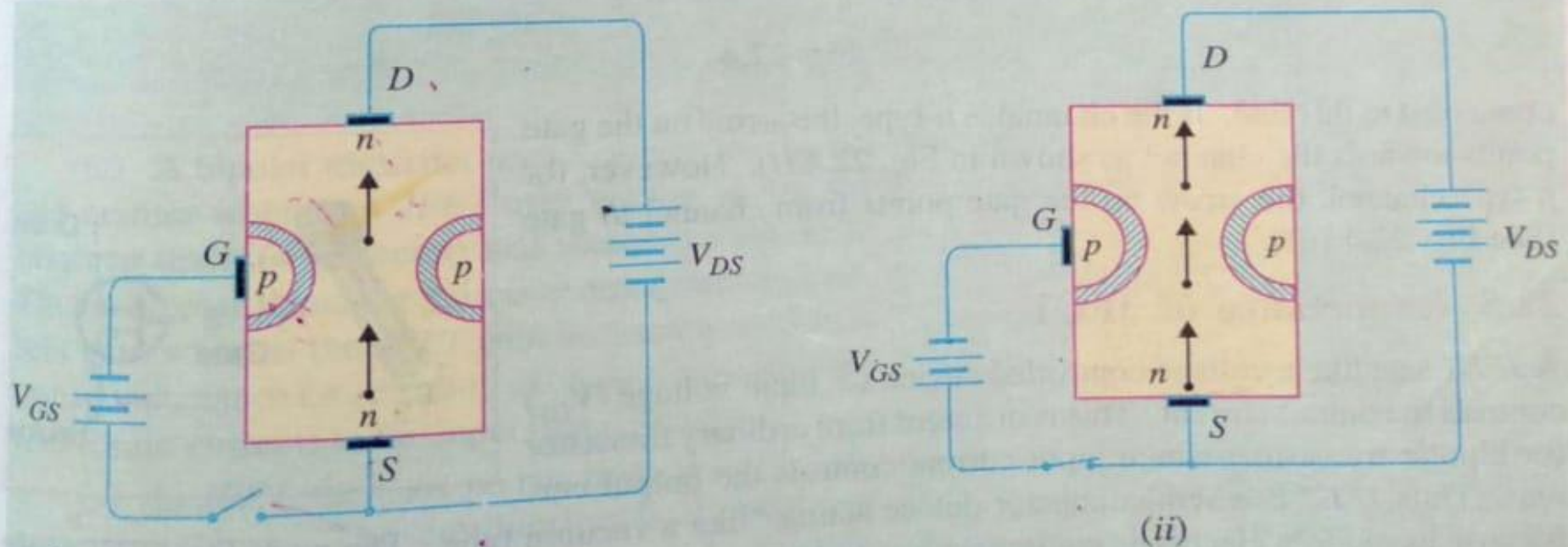
Fig. 22.2

### 22.3 Working Principle of JFET

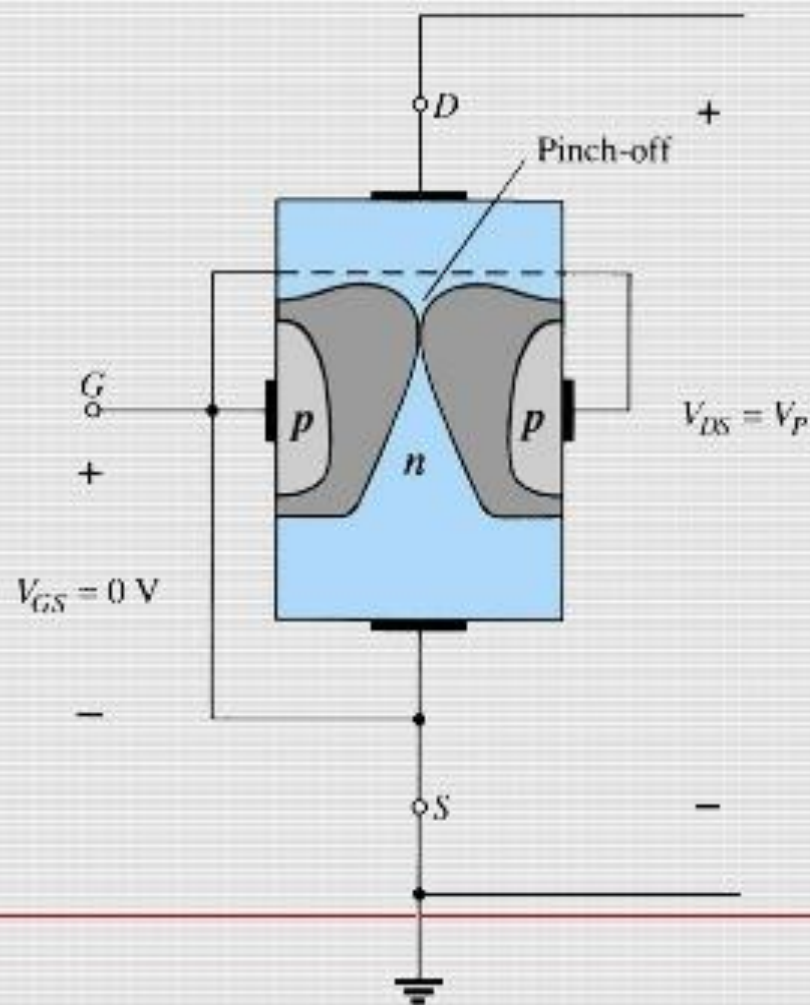
Fig. 22.3 shows the circuit of  $n$ -channel JFET with normal polarities. The circuit action is as follows:

(i) When a voltage  $V_{DS}$  is applied between drain and source terminals and voltage on the gate is zero [ See Fig. 22.3 (i) ], the two  $pn$  junctions at the sides of the bar establish depletion layers. The electrons will flow from source to drain through a channel between the depletion layers. The size of these layers determines the width of the channel and hence the current conduction through the bar.

(ii) When a reverse voltage  $V_{GS}$  is applied between the gate and source [See Fig. 22.3 (ii)], the width of the depletion layers is increased. This reduces the width of conducting channel, thereby increasing the resistance of  $n$ -type bar. Consequently, the current from source to drain is decreased. On the other hand, if the reverse voltage on the gate is decreased, the width of the depletion layers also decreases. This increases the width of the conducting channel and hence source to drain current.

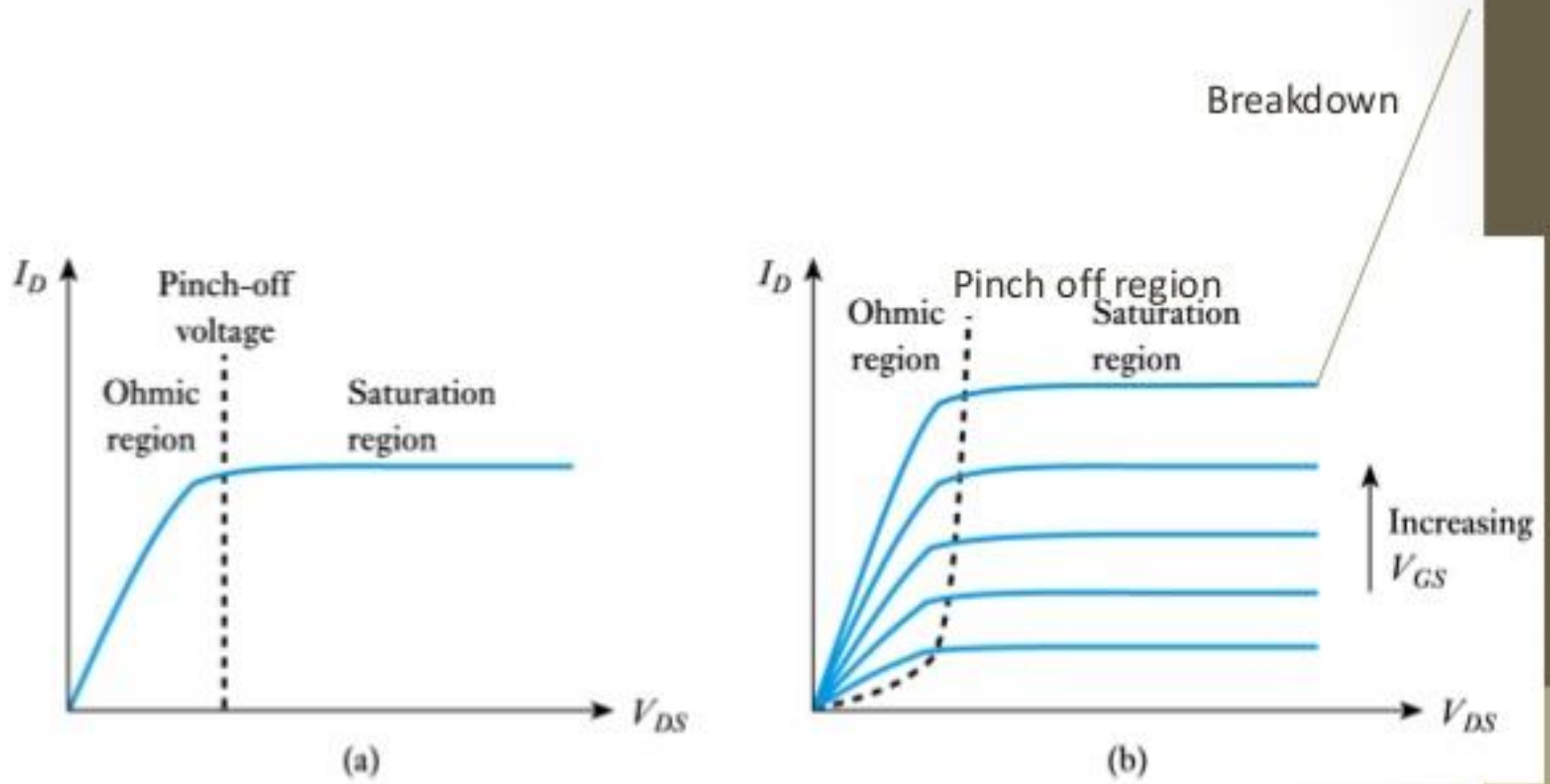


Pinch-off ( $V_{GS} = 0 \text{ V}$ ,  $V_{DS} = V_P$ ).





- **JFET output characteristics For  $V_{GS}$**



During the negative half-cycle of the signal, the reverse voltage on the gate increases. Consequently, the drain current decreases. The result is that a small change in voltage at the gate produces a large change in drain current. These large variations in drain current produce large output across the load  $R_L$ . In this way, *JFET* acts as an amplifier.

## 22.8 Output Characteristics of JFET

The curve between drain current ( $I_D$ ) and drain-source voltage ( $V_{DS}$ ) of a *JFET* at constant gate-source voltage ( $V_{GS}$ ) is known as *output characteristics of JFET*. Fig. 22.7 shows the circuit for determining the output characteristics of *JFET*. Keeping  $V_{GS}$  fixed at some value, say 1V, the drain-source voltage is changed in steps. Corresponding to each value of  $V_{DS}$ , the drain current  $I_D$  is noted. A plot of these values gives the output characteristic of *JFET* at  $V_{GS} = 1V$ . Repeating similar procedure, output characteristics at other gate-source voltages can be drawn. Fig. 22.8 shows a family of output characteristics.

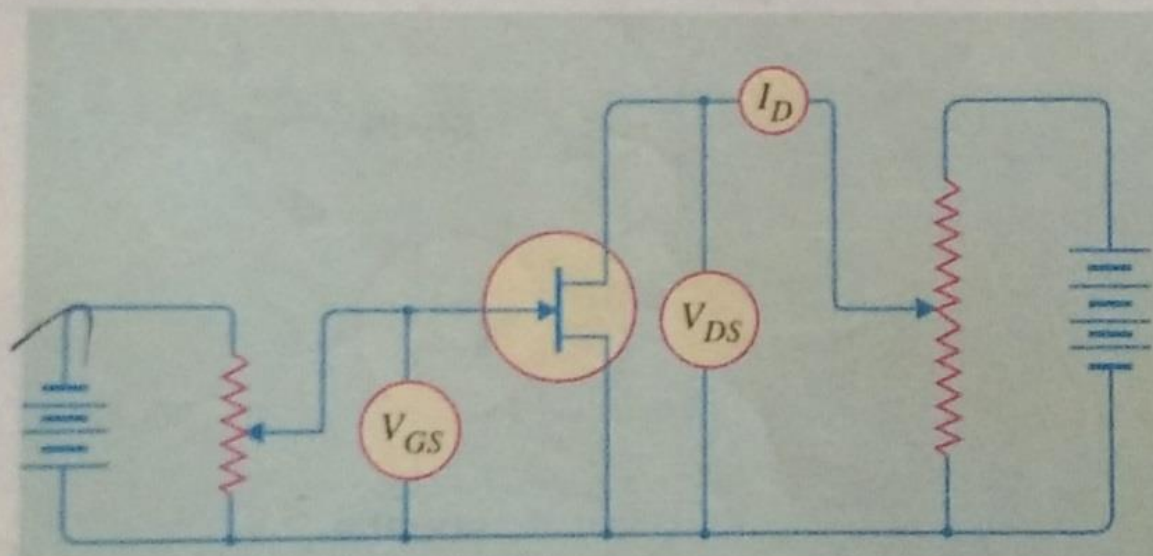


Fig. 22.7

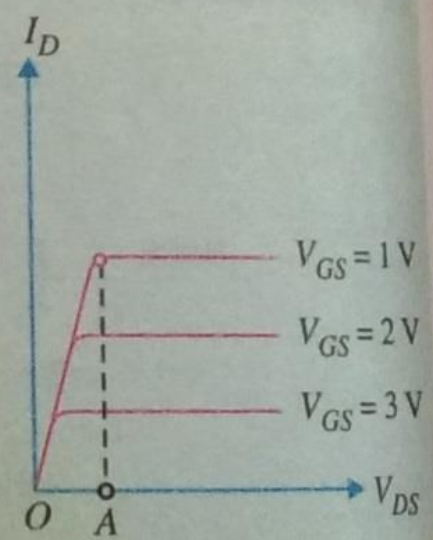
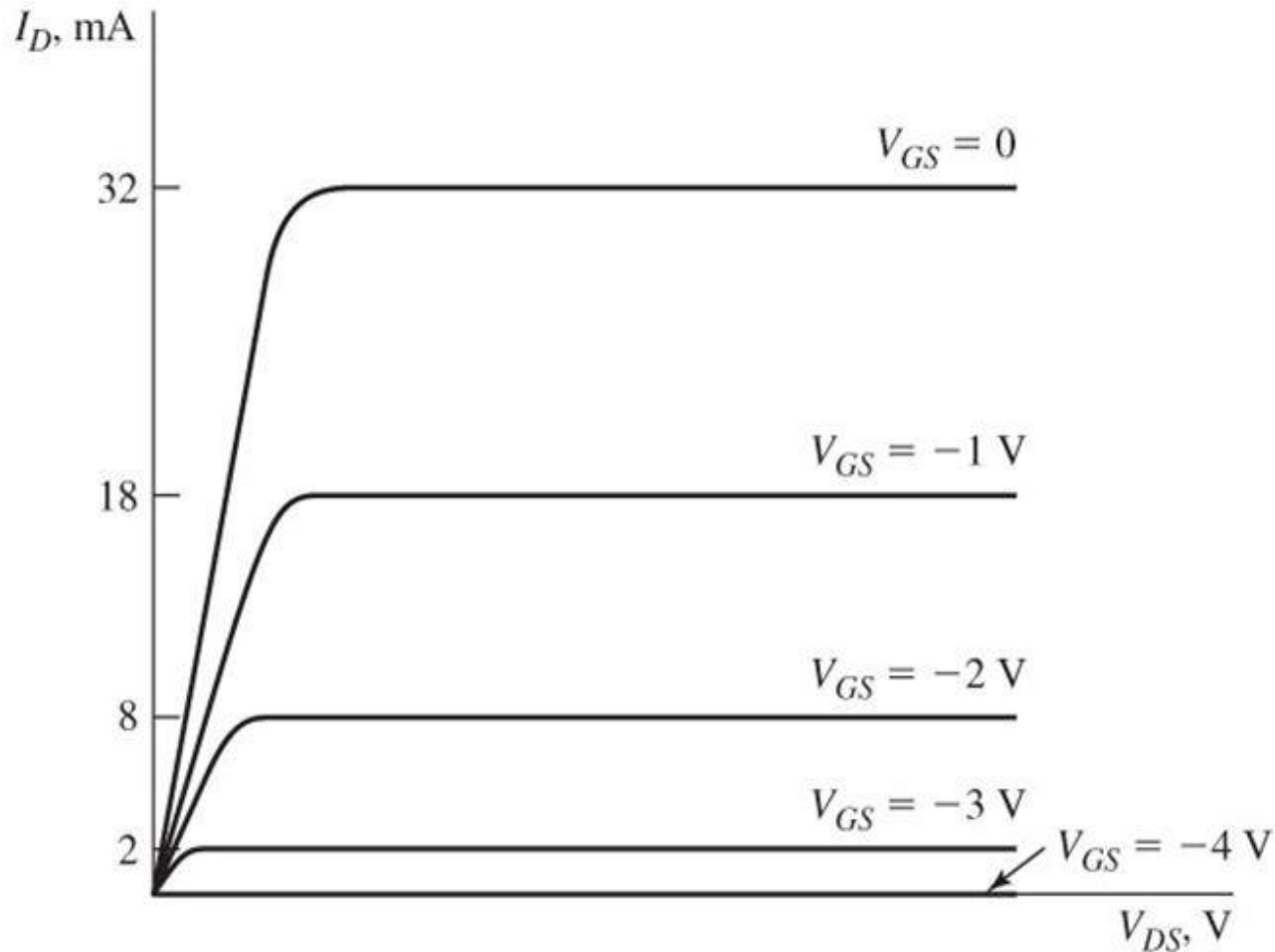


Fig. 22.8

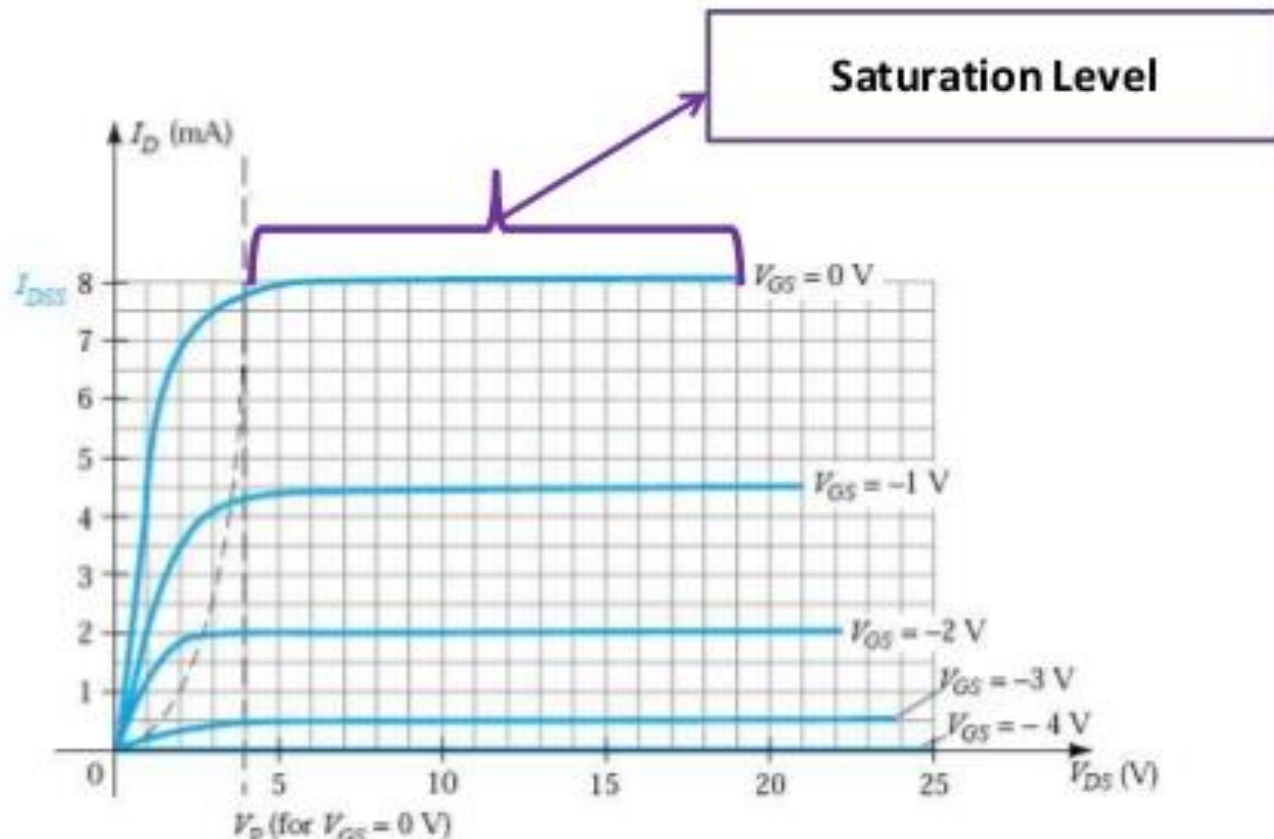
The following points may be noted from the characteristics :

# Drain characteristics for an ideal representative N-channel JFET.



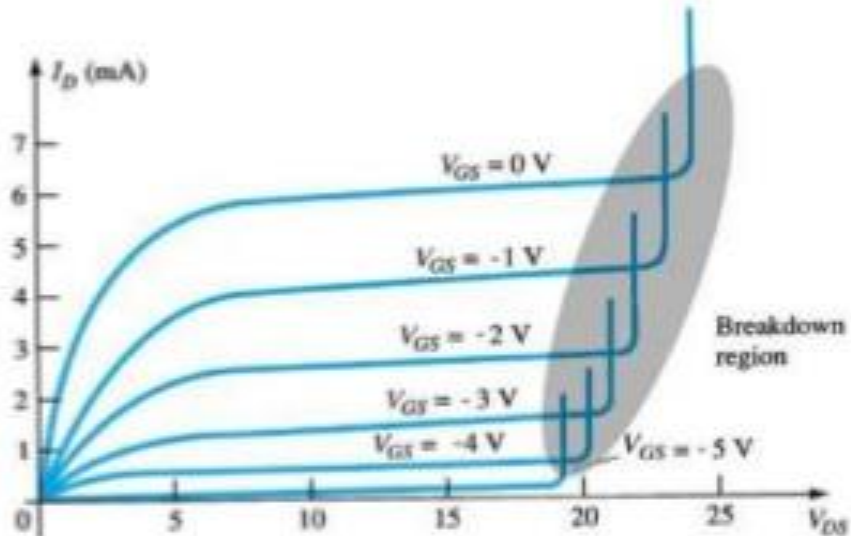
# Saturation Level

- After pinch off voltage the drain current become constant, this constant level is known as saturation level .

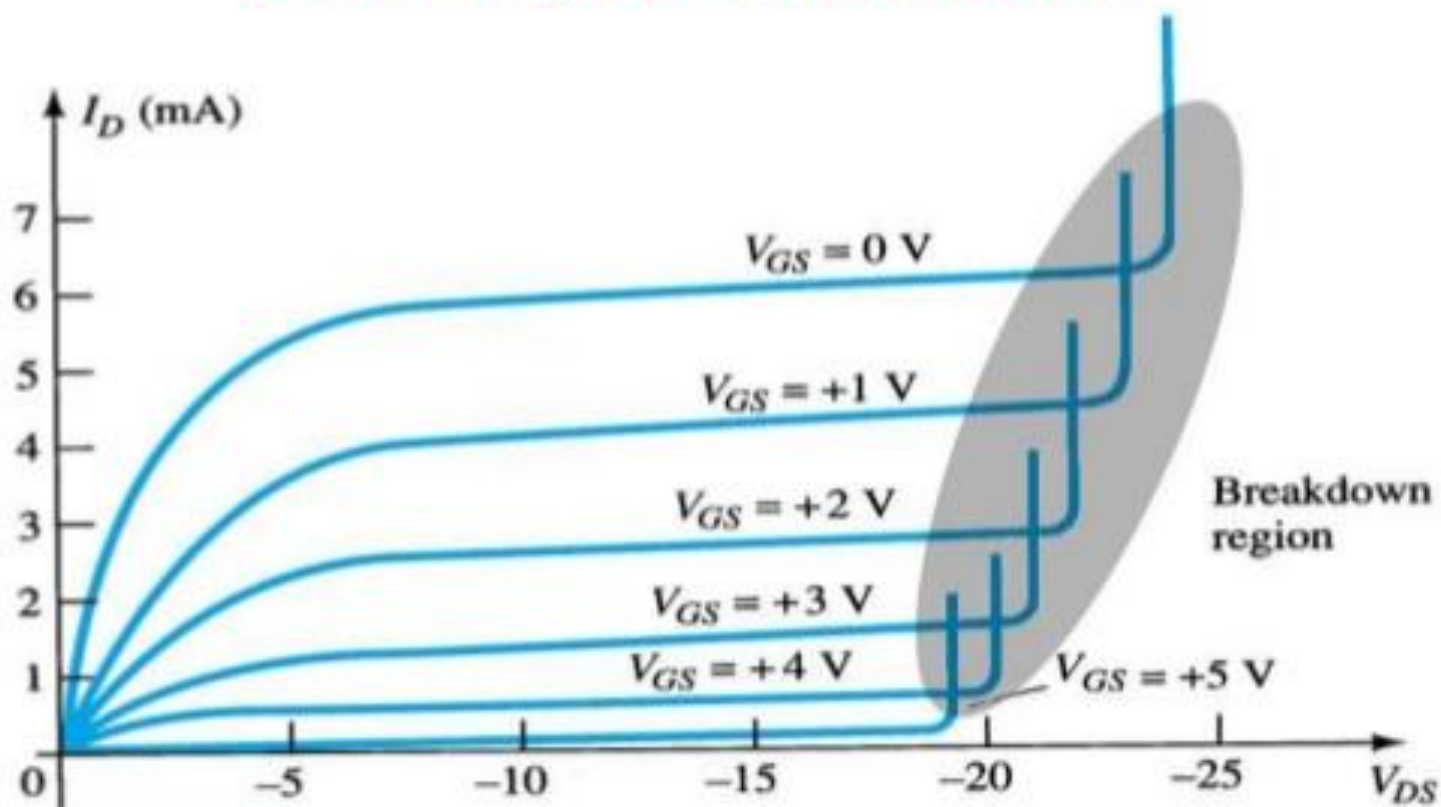


## Break Down Region

- It is the region, when the drain-source voltage ( $V_{DS}$ ) is high enough to cause the JFET's resistive channel to breakdown and pass uncontrolled maximum current .



## P-Channel JFET Characteristics



As  $V_{GS}$  increases more positively

- the depletion zone increases
- $I_D$  decreases ( $I_D < I_{DSS}$ )
- eventually  $I_D = 0$  A

Also note that at high levels of  $V_{DS}$  the JFET reaches a breakdown situation.  $I_D$  increases uncontrollably if  $V_{DS} > V_{DSmax}$ .

1. **Shorted-gate drain current ( $I_{DSS}$ ).** It is the drain current with source short-circuited to gate (i.e.  $V_{GS} = 0$ ) and drain voltage ( $V_{DS}$ ) equal to pinch off voltage. It is sometimes called zero-bias current.

Fig 22.9 shows the JFET circuit with  $V_{GS} = 0$  i.e., source shorted-circuited to gate. This is normally called shorted-gate condition. Fig. 22.10 shows the graph between  $I_D$  and  $V_{DS}$  for the shorted gate condition. The drain current rises rapidly at first and then levels off at pinch off voltage  $V_P$ . The drain current has now reached the maximum value  $I_{DSS}$ . When  $V_{DS}$  is increased beyond  $V_P$ , the depletion layers expand at the top of the channel. The channel now acts as a current limiter and holds drain current constant at  $I_{DSS}$ .

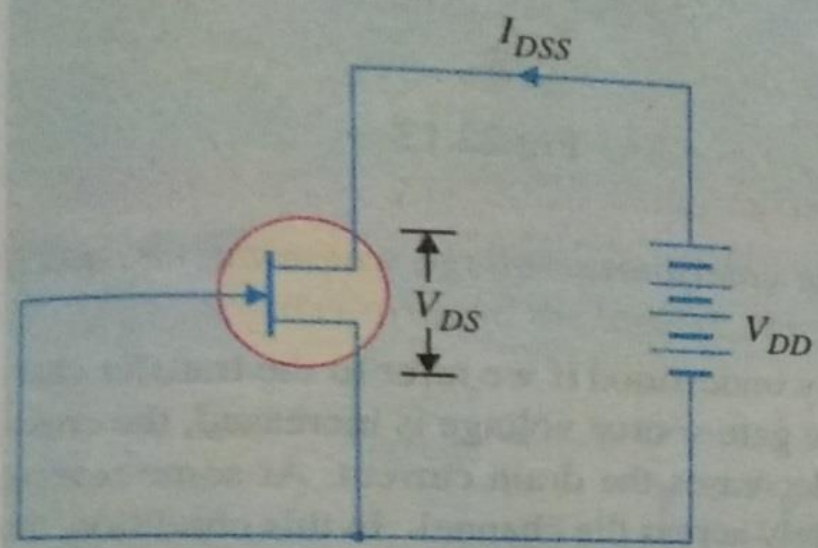


Fig. 22.9

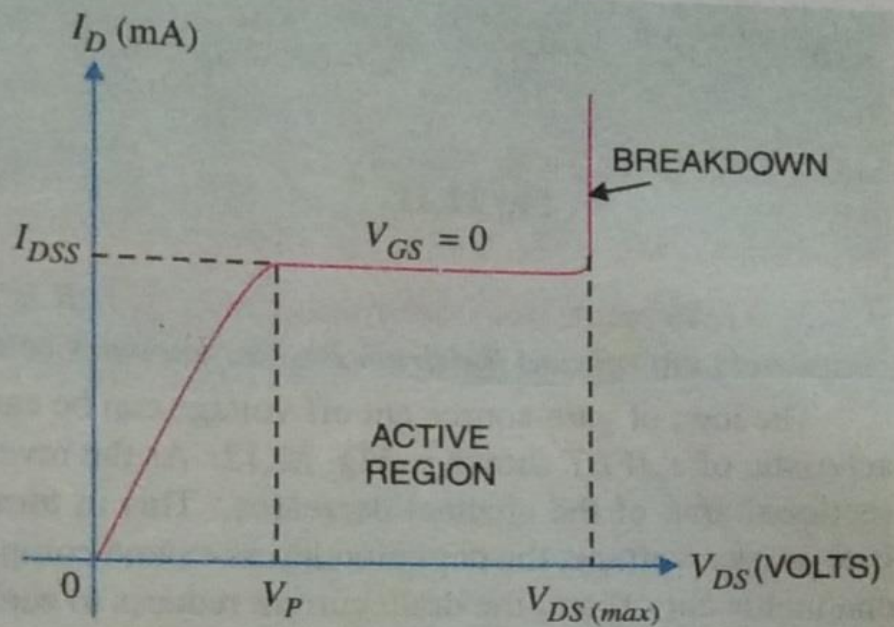
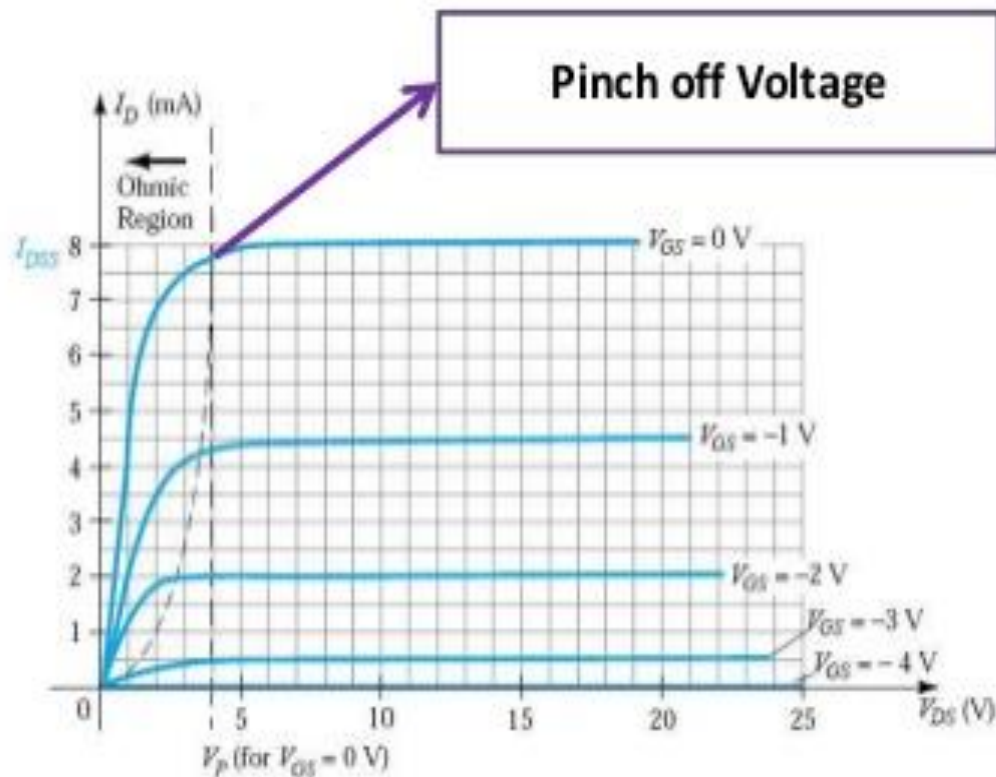


Fig. 22.10

The following points may be noted carefully :

## Pinch off Voltage ( $V_P$ )

- It is the minimum drain source voltage at which the drain current essentially become constant.





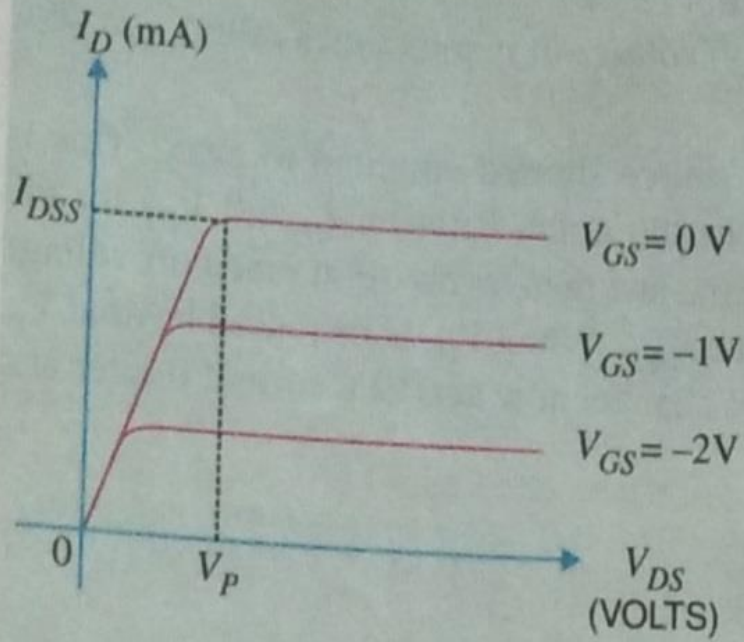


Fig 22.11

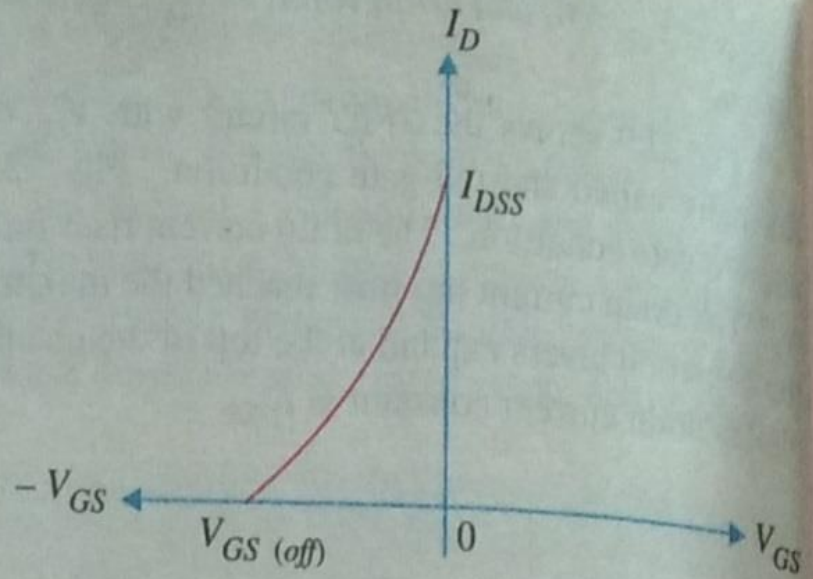


Fig 22.12

**3. Gate-source cut off voltage  $V_{GS(off)}$ .** It is the gate-source voltage where the channel is completely cut off and the drain current becomes zero.

The idea of gate-source cut off voltage can be easily understood if we refer to the transfer characteristic of a JFET shown in Fig. 22.12. As the reverse gate-source voltage is increased, the cross-sectional area of the channel decreases. This in turn decreases the drain current. At some reverse gate-source voltage, the depletion layers extend completely across the channel. In this condition, the channel is cut off and the drain current reduces to zero. The gate voltage at which the channel is cut off (i.e. channel becomes non-conducting) is called gate-source cut off voltage  $V_{GS(off)}$ .

# JFET Parameters

Electrical behavior is described in terms of the parameters of the Device. They are obtained from the characteristics. Important Parameters for FET are

- 1.DC Drain resistance
- 2.AC drain Resistance
- 3.Transconductance

(v) A JFET has a smaller size, longer life and high efficiency.

## 22.12 Parameters of JFET

Like vacuum tubes, a JFET has certain parameters which determine its performance in a circuit. The main parameters of a JFET are (i) a.c. drain resistance (ii) transconductance (iii) amplification factor.

(i) **a.c. drain resistance ( $r_d$ )**. Corresponding to the a.c. plate resistance, we have a.c. drain resistance in a JFET. It may be defined as follows :

*It is the ratio of change in drain-source voltage ( $\Delta V_{DS}$ ) to the change in drain current ( $\Delta I_D$ ) at constant gate-source voltage i.e.*

$$\text{a.c. drain resistance, } r_d = \frac{\Delta V_{DS}}{\Delta I_D} \text{ at constant } V_{GS}$$

For instance, if a change in drain voltage of 2 V produces a change in drain current of 0.02 mA, then,

$$\text{a.c. drain resistance, } r_d = \frac{2 \text{ V}}{0.02 \text{ mA}} = 100 \text{ k}\Omega$$

Referring to the output characteristics of a JFET in Fig. 22.8, it is clear that above the pinch off voltage, the change in  $I_D$  is small for a change in  $V_{DS}$  because the curve is almost flat. Therefore, drain resistance of a JFET has a large value, ranging from 10 k $\Omega$  to 1 M $\Omega$ .

(ii) **Transconductance ( $g_{fs}$ )**. The control that the gate voltage has over the drain current is measured by transconductance  $g_{fs}$  and is similar to the transconductance  $g_m$  of the tube. It may be defined as follows :

*It is the ratio of change in drain current ( $\Delta I_D$ ) to the change in gate-source voltage ( $\Delta V_{GS}$ ) at constant drain-source voltage i.e.*

Referring to the output characteristics of a *JFET* in Fig. 22.8, it is clear that above the pinch off voltage, the change in  $I_D$  is small for a change in  $V_{DS}$  because the curve is almost flat. Therefore, drain resistance of a *JFET* has a large value, ranging from  $10\text{ k}\Omega$  to  $1\text{ M}\Omega$ .

(ii) **Transconductance ( $g_{fs}$ )**. The control that the gate voltage has over the drain current is measured by transconductance  $g_{fs}$  and is similar to the transconductance  $g_m$  of the tube. It may be defined as follows :

*It is the ratio of change in drain current ( $\Delta I_D$ ) to the change in gate-source voltage ( $\Delta V_{GS}$ ) at constant drain-source voltage i.e.*

$$\text{Transconductance, } g_{fs} = \frac{\Delta I_D}{\Delta V_{GS}} \text{ at constant } V_{DS}$$

The transconductance of a *JFET* is usually expressed either in mA/volt or micromho. As an example, if a change in gate voltage of  $0.1\text{ V}$  causes a change in drain current of  $0.3\text{ mA}$ , then,

$$\begin{aligned} \text{Transconductance, } g_{fs} &= \frac{0.3\text{ mA}}{0.1\text{ V}} = 3\text{ mA/V} = 3 \times 10^{-3}\text{ A/V or mho} \\ &= 3 \times 10^{-3} \times 10^6\ \mu\text{ mho} = 3000\ \mu\text{ mho} \end{aligned}$$

(iii) **Amplification factor ( $\mu$ )**. *It is the ratio of change in drain-source voltage ( $\Delta V_{DS}$ ) to the change in gate-source voltage ( $\Delta V_{GS}$ ) at constant drain current i.e.*

$$\text{Amplification factor, } \mu = \frac{\Delta V_{DS}}{\Delta V_{GS}} \text{ at constant } I_D$$

## Features of JFET

- JFET is a voltage controlled device i.e. input voltage ( $V_{GS}$ ) control the output current ( $I_D$ ).
- In JFETs, the width of a junction is used to control the effective cross-sectional area of the channel through which current conducts.
- It is always operated with Gate-Source p-n junction in reverse bias.
- Because of reverse bias it has high input impedance.
- In JFET the gate current is zero i.e.  $I_G=0$ .

## Advantages

- It is simpler to fabricate, smaller in size.
- It has longer life and higher efficiency.
- It has high input impedance.
- It has negative temperature coefficient of resistance .
- It has high power gain.

## Application of JFET

- Voltage controlled resistor
- Analog switch or gate
- Act as an amplifier
- Low-noise amplifier
- Constant current source

**JFET****BJT**

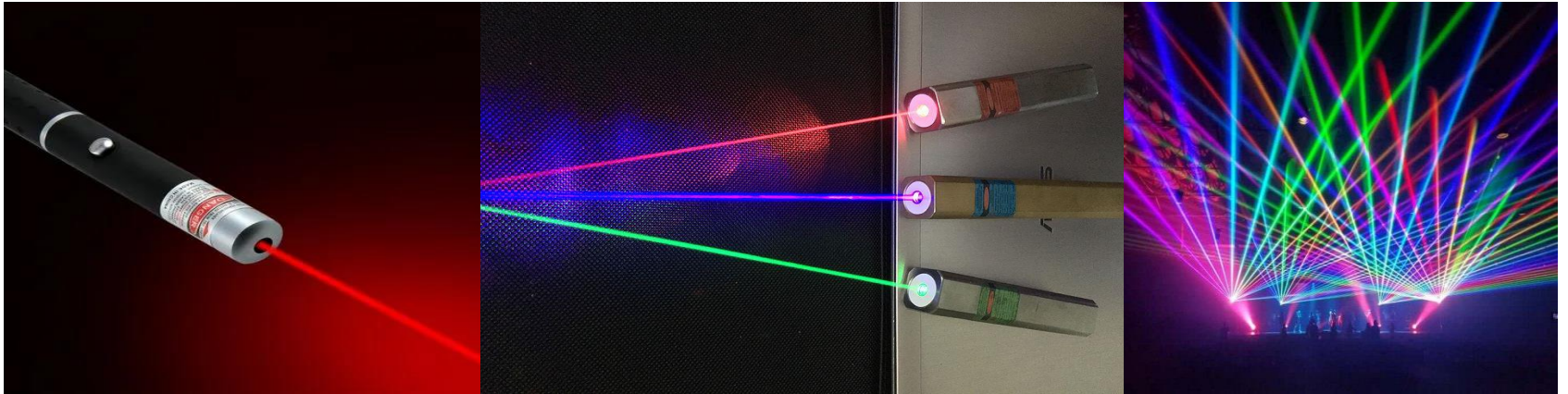
1.	Unipolar device (current conduction is only due to one type of majority carrier either electron or hole).	Bipolar device ( current condition, by both types of carriers, i.e., majority and minority- electrons and holes )
2.	The operation depends on the control of a junction depletion width under reverse bias.	The operation depends on the injection of minority carriers across a forward biased junction.
3.	Voltage driven device. The current through the two terminals is controlled by a voltage at the third terminal (gate).	Current driven device. The current through the two terminals is controlled by a current at the third terminal (base).
4.	Low noise level.	High noise level.
5.	High input impedance (due to reverse bias).	Low input impedance (due to forward bias).
6.	Gain is characterised by transconductance.	Gain is characterized by voltage gain.
7.	Better thermal stability.	Less thermal stability.



Thank You!



# LASER



*Ms. R.GOWTHAR*  
*Assistant Professor*  
*Department of physics*  
*Jamal Mohamed College*  
*Trichy-20*

# LASER

**LASER** stands for '*Light Amplification by Stimulated Emission of Radiation*'

Laser is a very intense, concentrated, highly parallel and monochromatic beam of light.

Coherence is very important property of Laser.

## Incoherent Light:

The light emitted from the Sun or other ordinary light sources such as tungsten filament and fluorescent tube lights is spread over a wide range of frequencies.

For eg. Sunlight is spread over Infra Red, Visible light and Ultra Violet spectrum. So, the amount of energy available at a particular frequency is very less and hence less intense.

Such light is irregular and mixed of different frequencies, directions and durations, and is incoherent.

Incoherent light is due to spontaneous and random emission of photons by the atoms in excited state. These photons will not be in phase with each other.



Incoherent Light

# Laser light differs from ordinary light

## Laser Light

- Mono-chromatic
- Directional
- Coherent

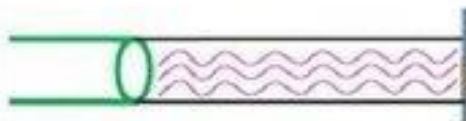


## Ordinary Light



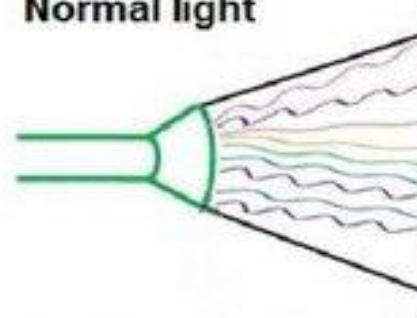
*Light Amplification by Stimulated Emission of Radiation*

### Laser light



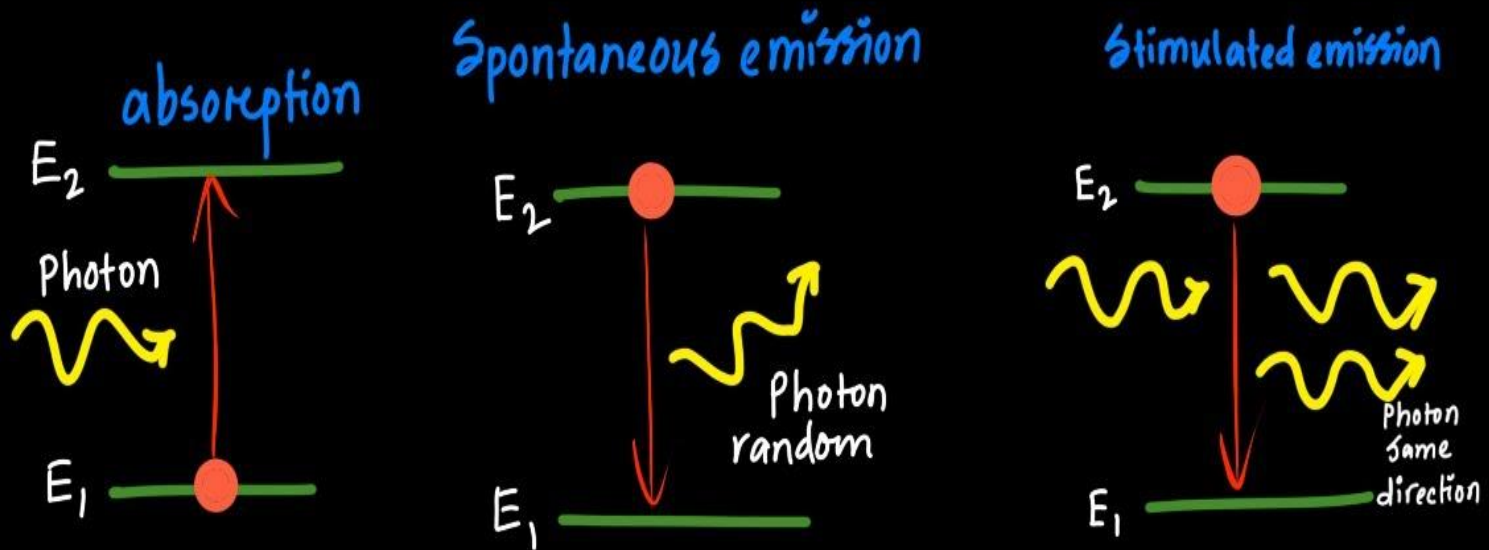
- 1- Monochromatic if visible
- 2- Coherent
- 3- Directional (Colimated i.e. with minimal divergence or parallel)
- 4- High intensity

### Normal light



- 1- Polychromatic
- 2- Noncoherent
- 3- Nondirectional (nocolimated i.e. Scattered)
- 4- Low intensity

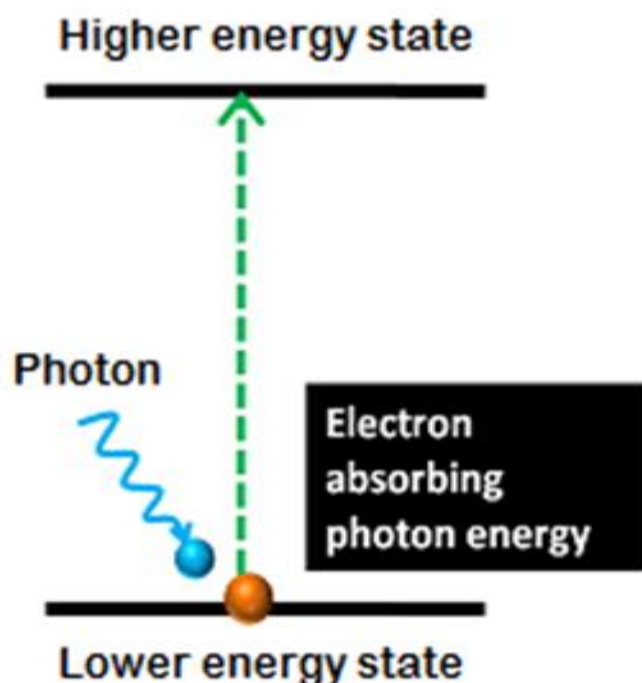
# Stimulated Emission Explained



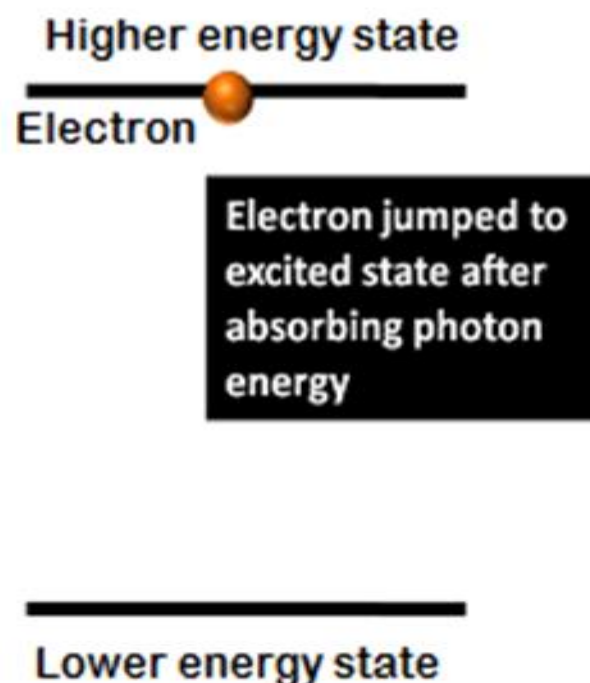
## Absorption of radiation or light

Energy

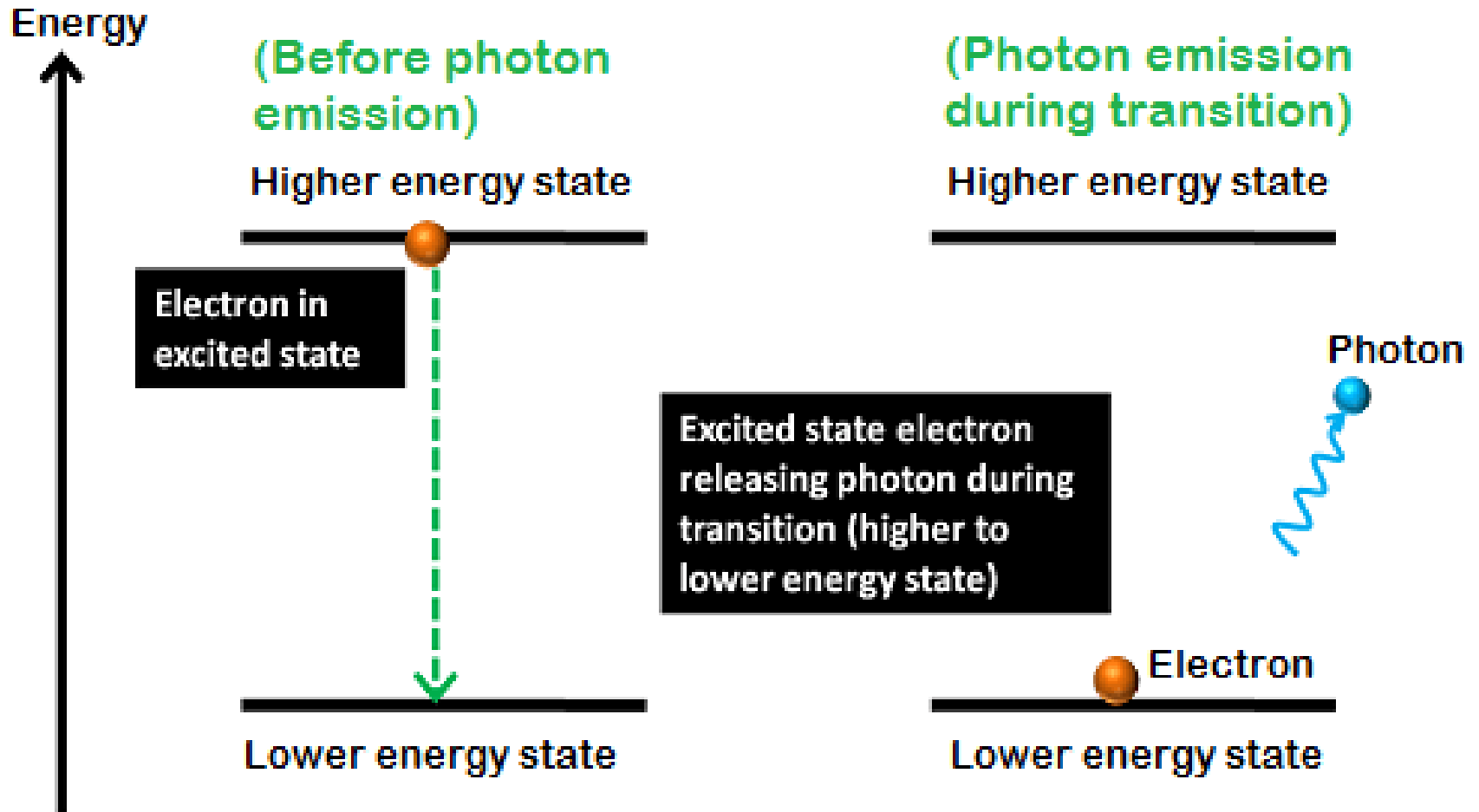
(During absorption)



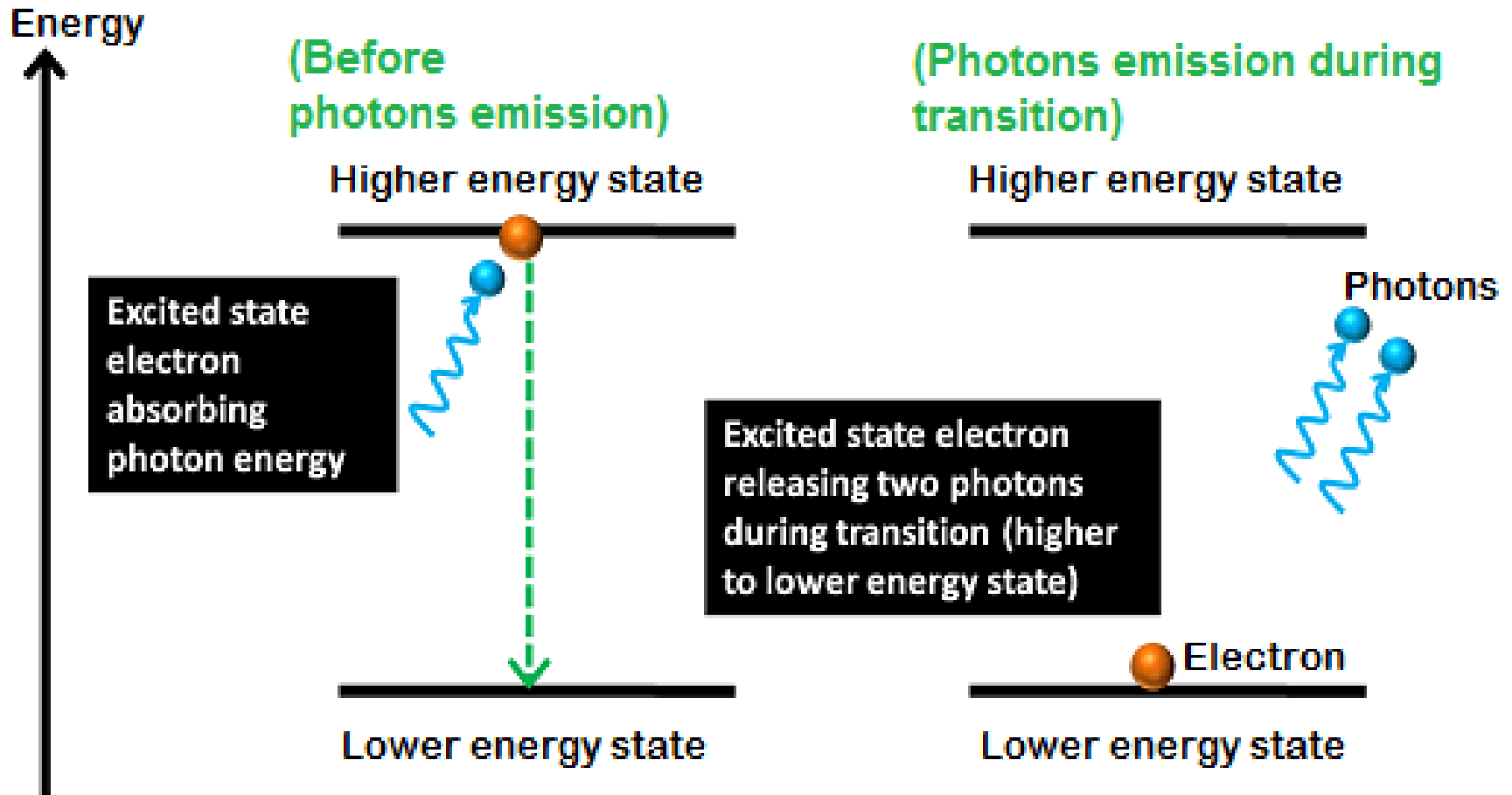
(After absorption)



# Spontaneous emission



# Stimulated emission



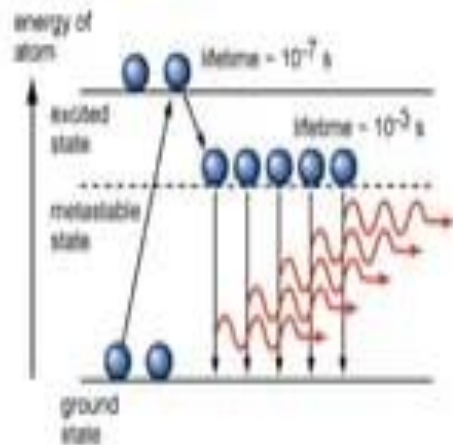


# Population inversion

- For light amplification by stimulated emission of radiation the population of excited state must be greater than the population of lower energy state. This condition is called population inversion.

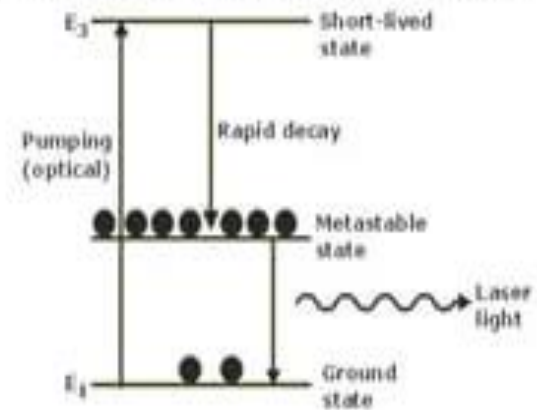
## Metastable states

Normally an electron in an excited state will make the transition to a lower state in a time of  $10^{-7}$ s. In contrast an electron may stay in a **metastable state** for  $10^{-3}$ s.



## Metastable states

To achieve population inversion we must have **metastable states**. These are excited states where electrons stay for unusually long times.



- **Laser Pumping:**
- The process to achieve the population inversion in the medium is called Pumping action. It is essential requirement for producing a laser beam.
- **Methods of pumping action**

The methods commonly used for pumping action are:

- 1. Optical pumping (Excitation by Photons)
- 2. Electrical discharge method (Excitation by electrons)
- 3. Direct conversion
- 4. In elastic atom – atom collision between atoms

## DIFFERENT PUMPING MECHANISMS :

*i. Optical pumping* : Exposure to electromagnetic radiation of frequency  $\nu = (E_2 - E_1)/h$  obtained from discharge flash tube results in pumping Suitable for solid state lasers.

*ii. Electrical discharge* : By inelastic atom-atom collisions, population inversion is established.

Suitable for Gas lasers

*iii. Chemical pumping* : By suitable chemical reaction in the active medium, population of excited state is made higher compared to that of ground state Suitable for liquid lasers.

*iv. Optical resonator* : A pair of mirrors placed on either side of the active medium is known as optical resonator. One mirror is completely silvered and the other is partially silvered. The laser beam comes out through the partially silvered mirror.

# Laser Applications



## Laser Applications

### Daily Applications

- Compact disk
- Laser printer
- Optical disc drives
- Optical computer
- Bar code scanner
- Holograms against forgery
- Fiber optic communications
- Free space communications
- Laser shows
- Holograms
- Kinetic sculptures

### Medical Applications

- Surgery:
  - Eyes
  - General
  - Dentistry
  - Dermatology
- Diagnostic Fluorescence
- Soft Laser

### Scientific Applications

- Basic Scientific Research
- Spectroscopy
- Nuclear Fusion
- Cooling Atoms
- Short Pulses, Study of Fast Processes

### Industrial Applications

- Measurements
- Straight Lines
- Material Processing
- Spectral Analysis

### Military Applications

- Laser range-finder
- Target designation
- Laser weapons
- Laser blinding

### Special Applications

- Energy Transport
- Laser Gyroscope
- Fiber Lasers





**Thank You**

# **TRANSISTORS**

*"The building blocks of  
electronics world"*

***Ms. R.GOWTHAR***  
***Assistant Professor***  
***Department of physics***  
***Jamal Mohamed College***  
***Trichy-20***





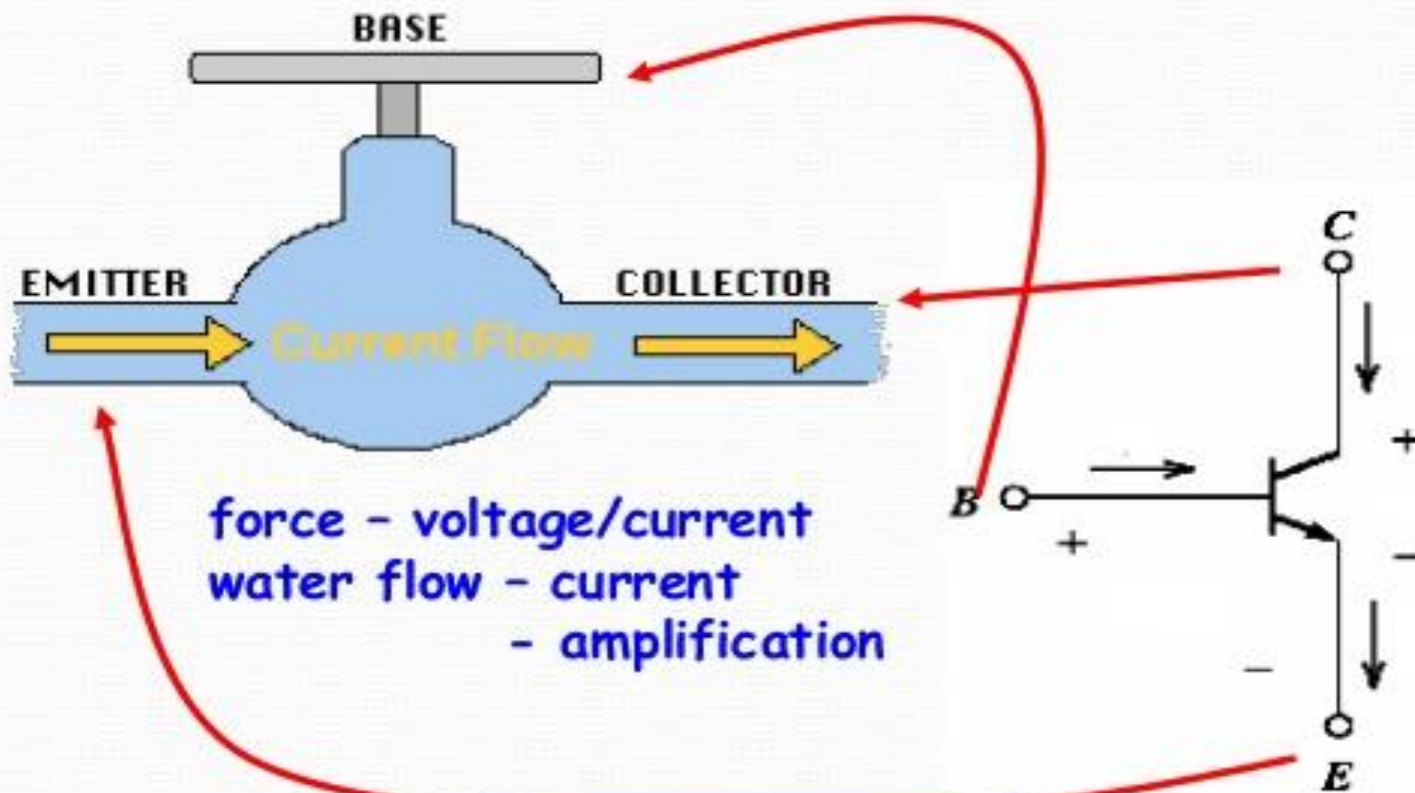


- ❖ *When a third doped element is added to a crystal diode in such a way that **two pn junctions are formed** the resulting device is known as **'TRANSISTOR'***
- ❖ *TRANSISTORS are far smaller than vacuum tubes, it have **no filament** and hence need **no heating power** and may be operated in any position.*
- ❖ *Transistor has now become the **'Heart of the most electronic applications'**.*

- ❖ *A transistor consists of **2 pn junction formed** by sandwiching either p -type (or) n- type semiconductor between a pair of opposites sides.*
- ❖ *A transistor has two pn junction diodes. **One junction is forward biased. Other junction is reversed junction.***
- ❖ *The **forward biased has low resistance path** whereas a reverse biased junction has high resistance path.*

- ❖ A 'TRANSISTOR' transfers a signal from a low resistance to high resistance.
- ❖ 'Trans' means the signal transfer property of the device
- ❖ while 'istor' means classifies it as a solid element in the same general family with resistors
- ❖ **Transfer + Resistors = TRANSISTOR**

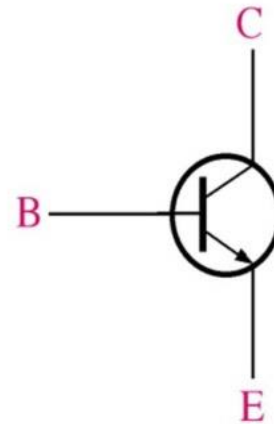
# Transistor operation



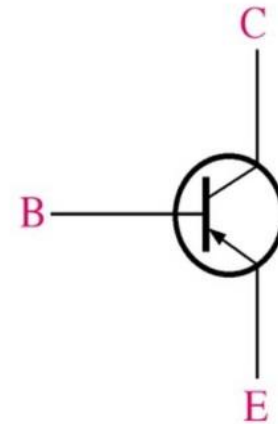
# Introduction

- A transistor is a device that can be used as either an amplifier or a switch. Transistor is current controlling device.

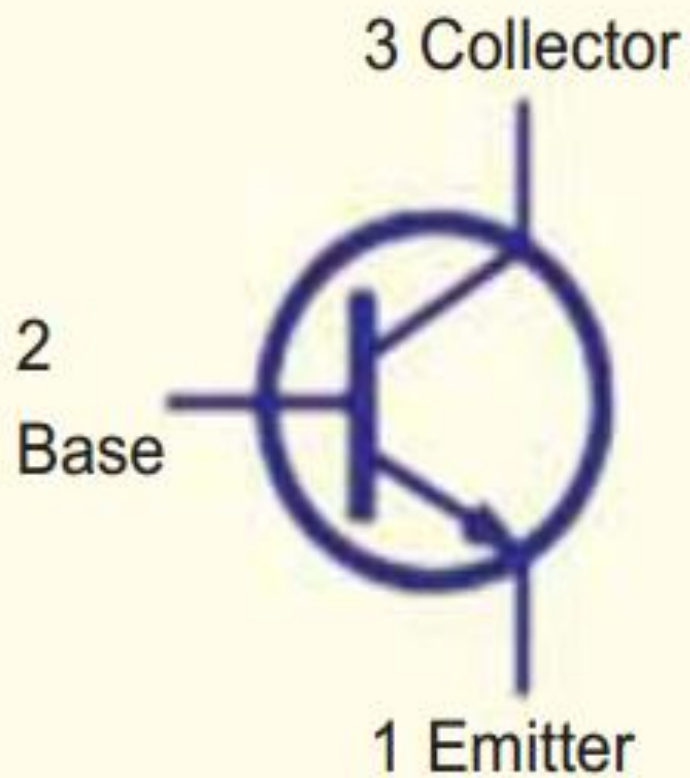
Transistors can be either **npn** or **pnp** type.



(a) *npn*



(b) *pnp*



# Transistor Definition

- Transistor is an electronic device made of three layers of semiconductor material that can act as an insulator and a conductor.
- The three layered transistor is also known as the bipolar junction transistor.

❖ **PNP Transistor Definition:**

The **transistor** in which one n-type material is doped with two p-type materials such type of **transistor** is known as "**PNP transistor**".

❖ It is a **current controlled device**.

❖ The small amount of base current controlled both the emitter and collector current.



## 11.5 Transistor Symbols

In the earlier diagrams, the transistors have been shown in diagrammatic form. However, for the sake of convenience, the transistors are represented by schematic diagrams. The symbols used for *npn* and *pnp* transistors are shown in Fig. 11.6.

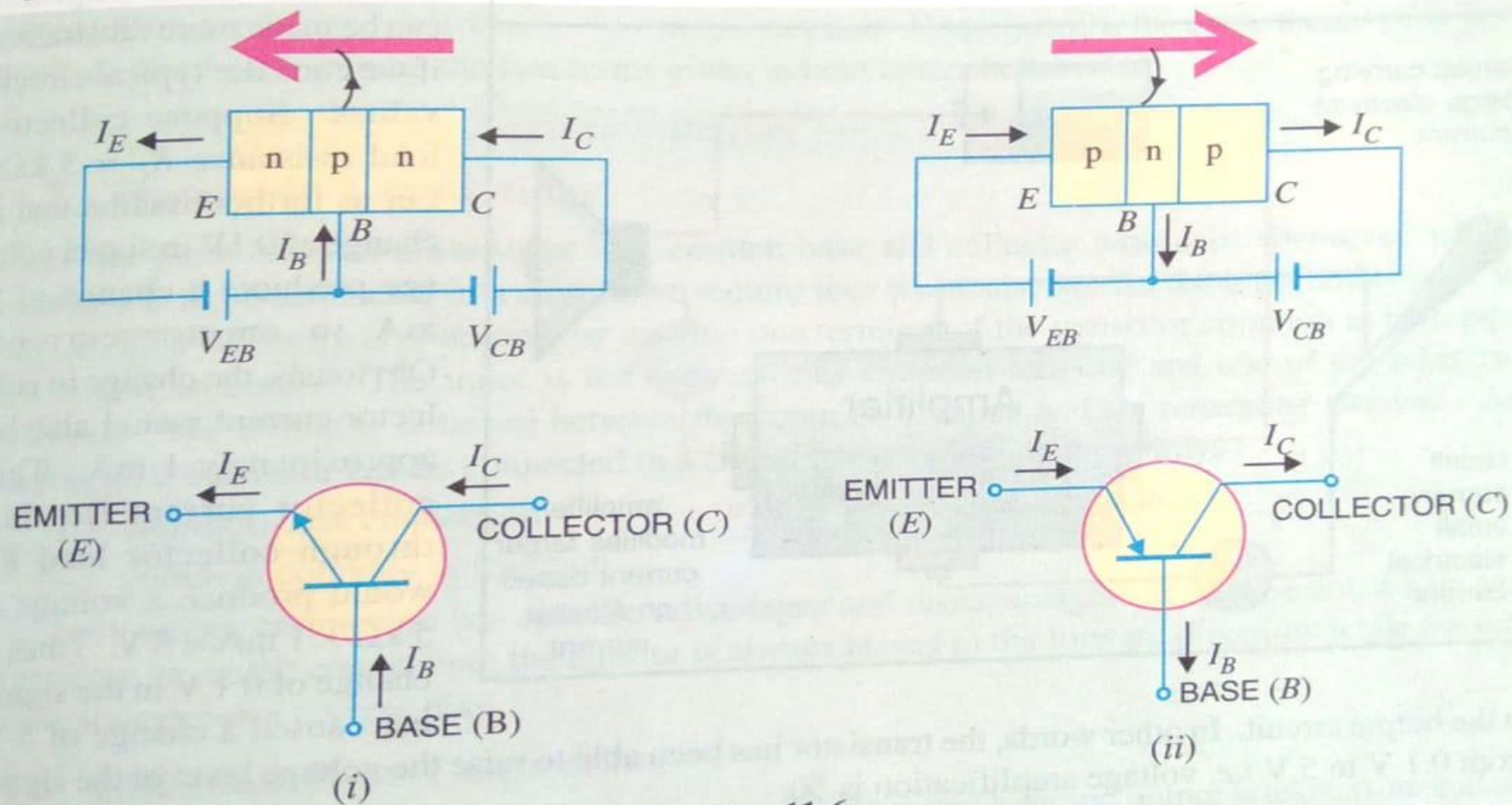


Fig. 11.6

Note that emitter is shown by an arrow which indicates the direction of conventional current flow with forward bias. For *npn* connection, it is clear that conventional current flows out of the emitter as indicated by the outgoing arrow in Fig. 11.6 (i). Similarly, for *pnp* connection, the conventional current flows into the emitter as indicated by inward arrow in Fig. 11.6 (ii).

**Collector**

**Base**



**Emitter**

**P-n-P**

**Collector**

**Base**

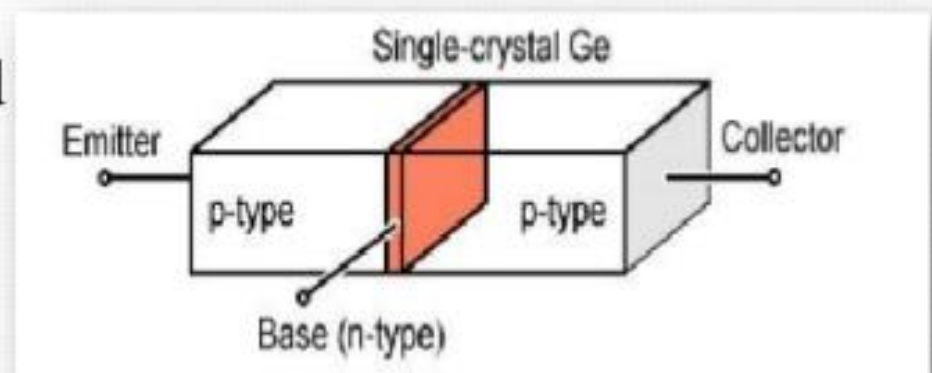


**Emitter**

**n-P-n**

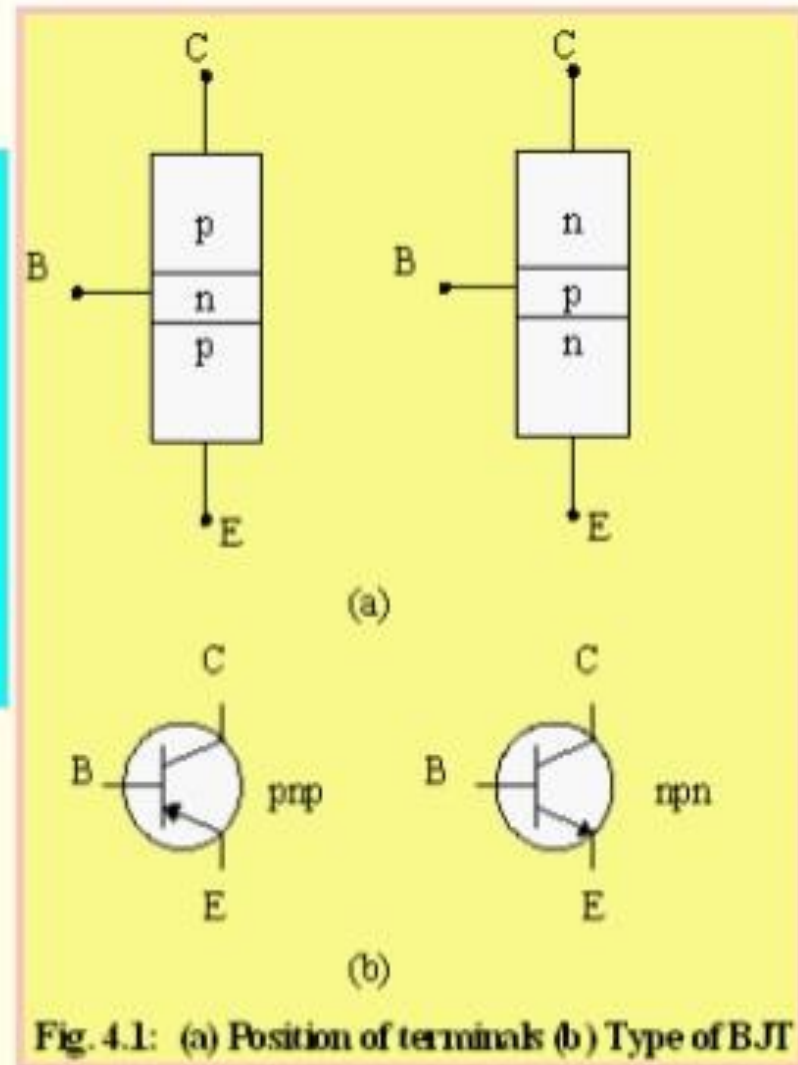
# Regions of a transistor

- A transistor has three regions namely,
- Emitter- heavily doped
- Base- lightly doped
- Collector- moderately doped

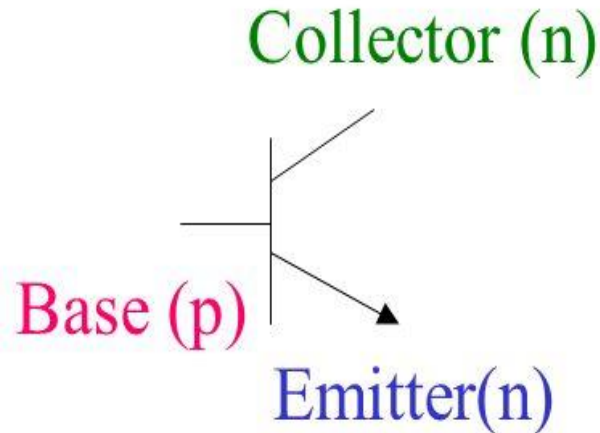


# Position of the terminals and symbol of transistor.

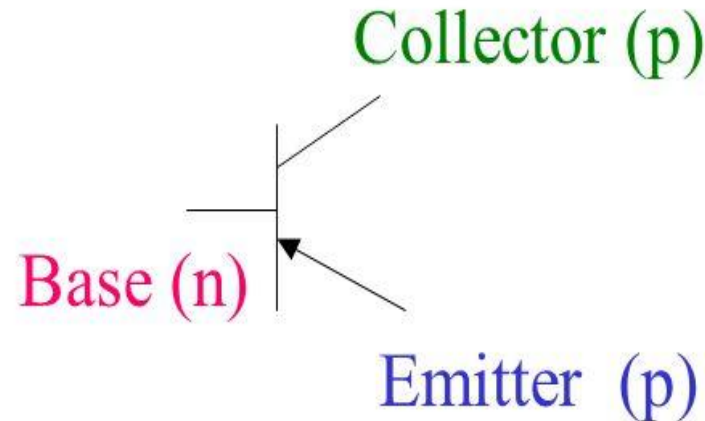
- Base is located at the middle and more thin from the level of collector and emitter
- The emitter and collector terminals are made of the same type of semiconductor material, while the base of the other type of material



## NPN transistor



## PNP transistor

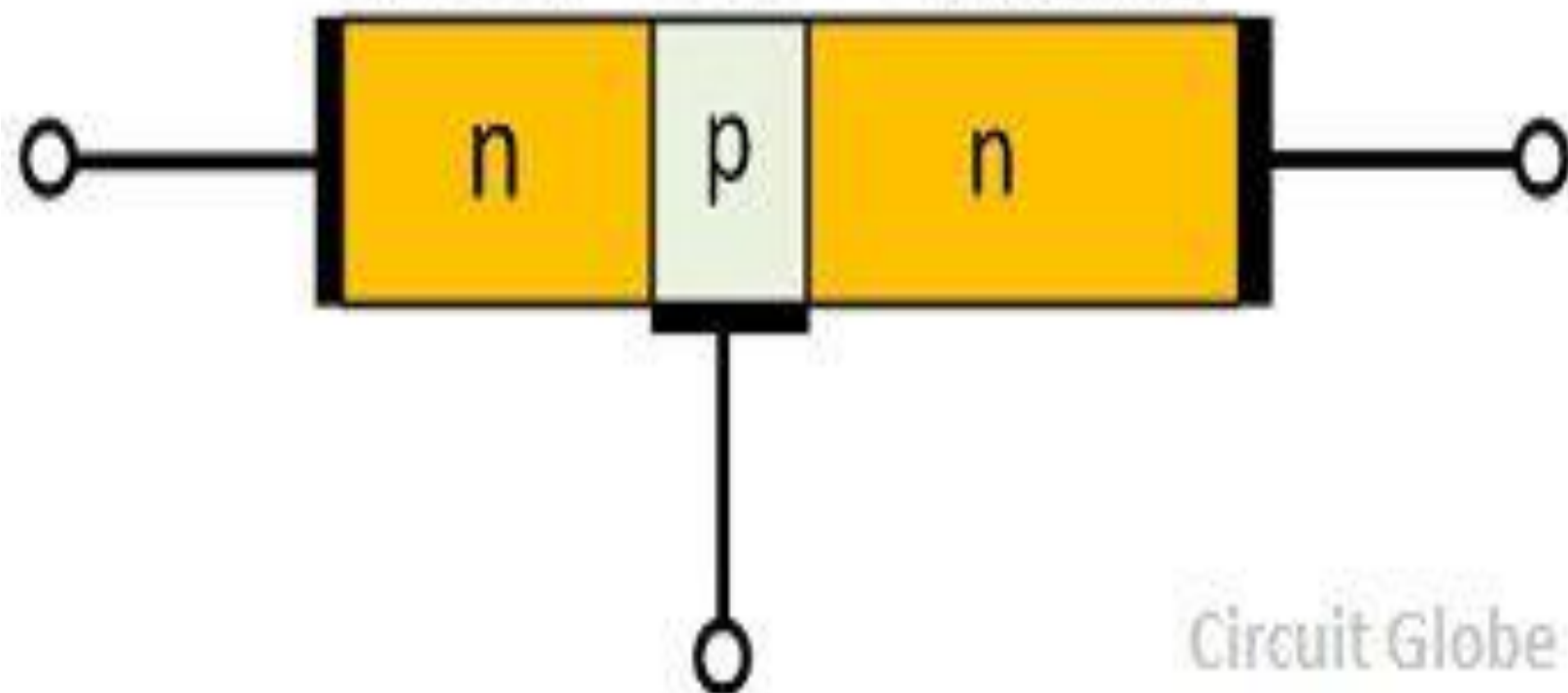


Emitter is moderately wide and highly doped

Base is very narrow and lightly doped

Collector is very wide and moderately doped

Emitter Base Collector

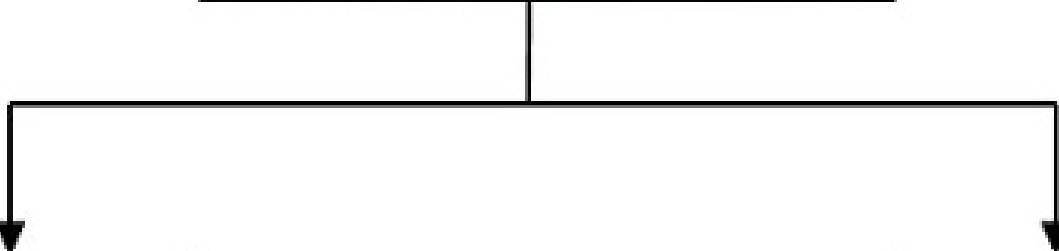


Circuit Globe

# Types of transistor

- BJT - Bipolar Junction Transistor
- UJT- Unipolar Junction Transistor
- FET - Field Effect Transistor
- MOS - Metal Oxide Semiconductor

TRANSISTORS



BJT

FET



PNP

NPN

JFET

MOSFET



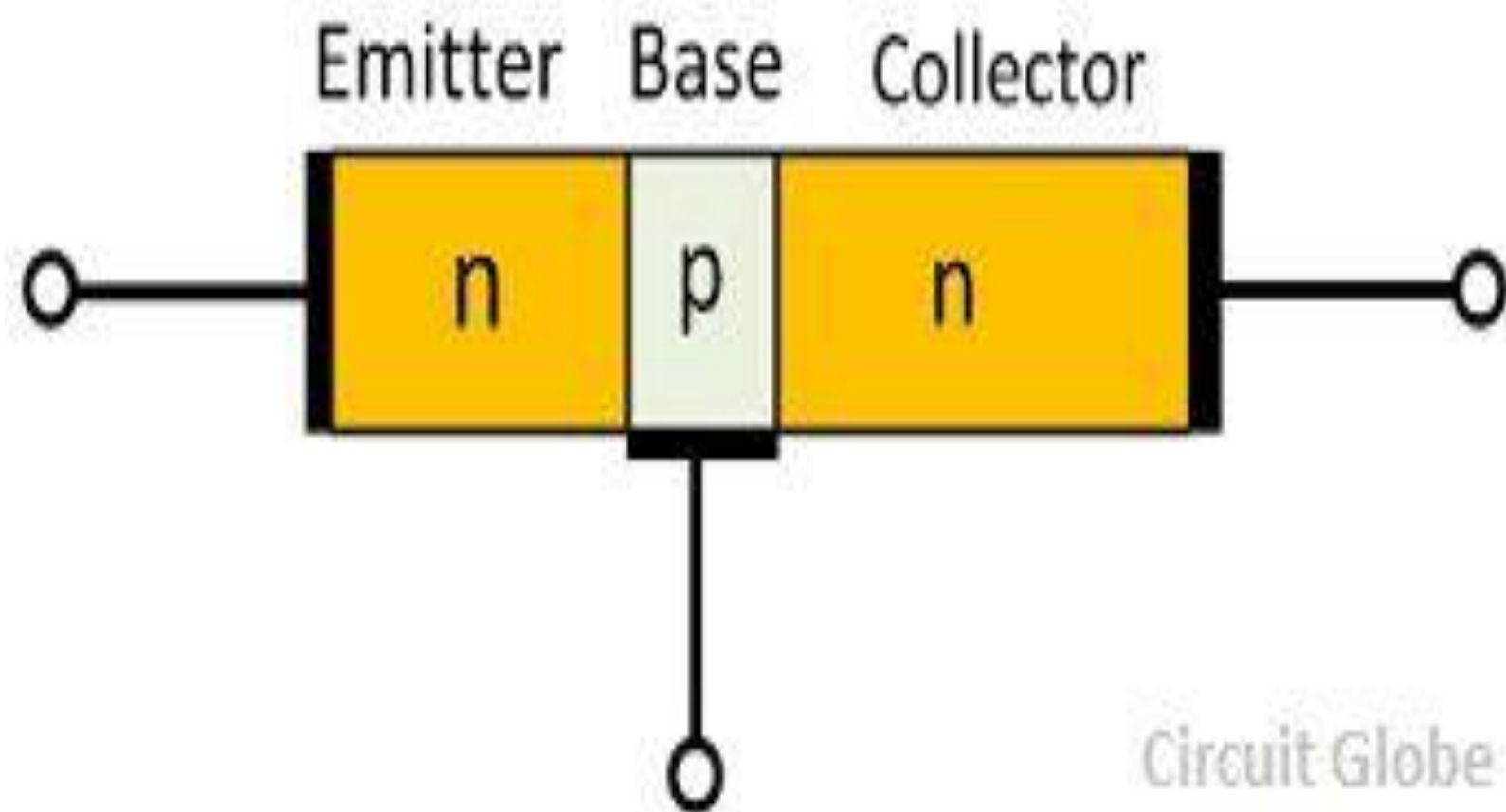
## 11.4 Transistor Action

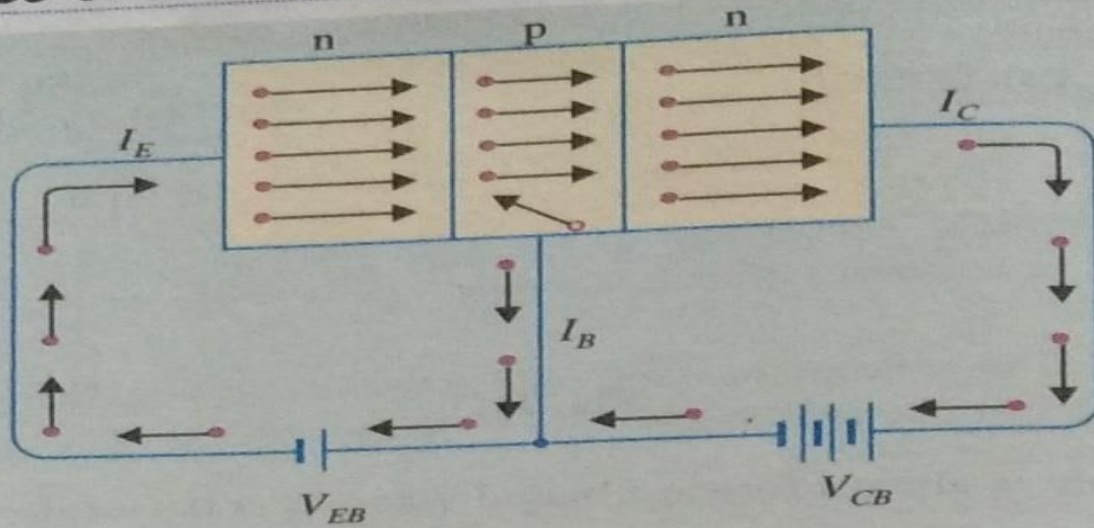
The emitter-base junction of a transistor is forward biased whereas collector-base junction is reverse biased. If for a moment, we ignore the presence of emitter-base junction, then *practically\** no current would flow in the collector circuit because of the reverse bias. However, if the emitter-base junction is also present, then forward bias on it causes the emitter current to flow. It is seen that this emitter current almost entirely flows in the collector circuit. Therefore, the current in the collector circuit depends upon the emitter current. If the emitter current is zero, then collector current is nearly zero. However, if the emitter current is 1mA, then collector current is also about 1mA. This is precisely what happens in a transistor. We shall now discuss this transistor action for *npn* and *pnp* transistors.

**(i) Working of npn transistor.** Fig. 11.4 shows the *npn* transistor with forward bias to emitter-base junction and reverse bias to collector-base junction. The forward bias causes the electrons in the *n*-type emitter to flow towards the base. This constitutes the emitter current  $I_E$ . As these electrons flow through the *p*-type base, they tend to combine with holes. As the base is lightly doped and very thin, therefore, only a few electrons (less than 5%) combine with holes to constitute base\*\* current  $I_B$ . The remainder (\*\*\*) more than 95%) cross over into the collector region to constitute collector current  $I_C$ . In this way, almost the entire emitter current flows in the collector circuit. It is clear that emitter current is the sum of collector and base currents *i.e.*

$$I_E = I_B + I_C$$

\* In actual practice, a very little current (a few  $\mu\text{A}$ ) would flow in the collector circuit. This is called

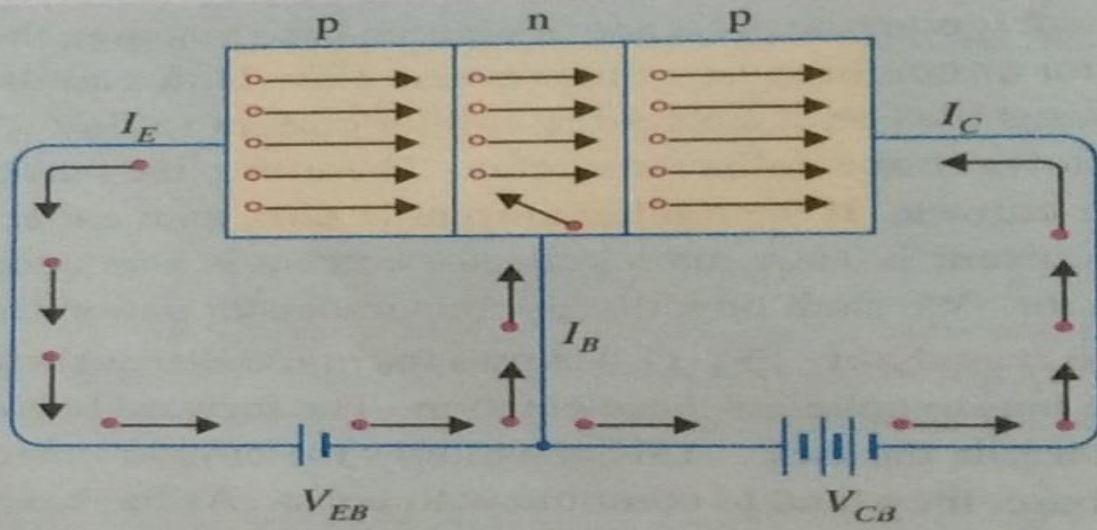




Basic connection of *nnp* transistor

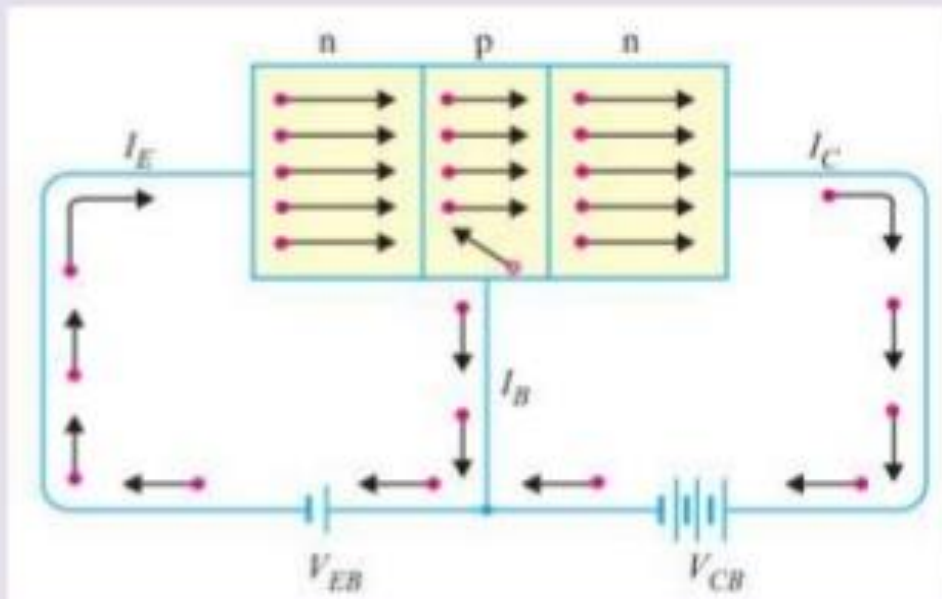
Fig. 11.4

(i) **Working of *pnp* transistor.** Fig. 11.5 shows the basic connection of a *pnp* transistor. The forward bias causes the holes in the *p*-type emitter to flow towards the base. This constitutes the emitter current  $I_E$ . As these holes cross into *n*-type base, they tend to combine with the electrons. As the base is lightly doped and very thin, therefore, only a few holes (less than 5%) combine with the



# Transistor Operation

## 1) Working of npn transistor:



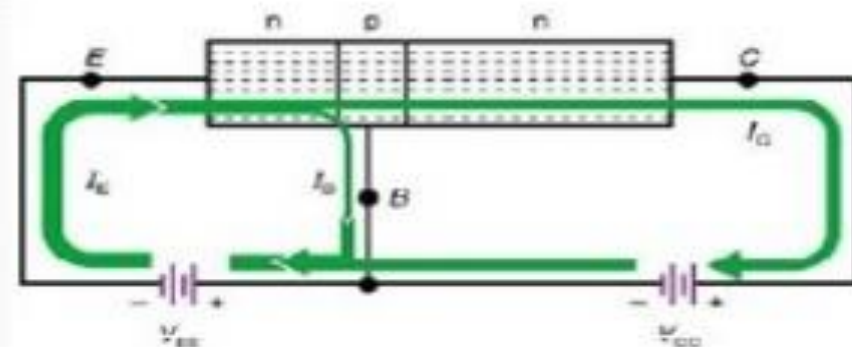
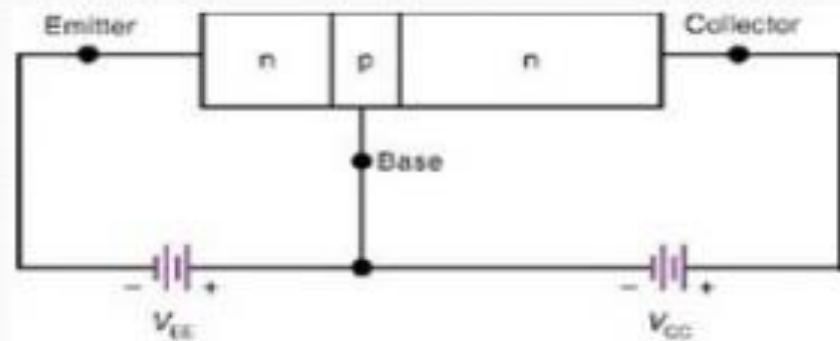
✓ Forward bias is applied to emitter-base junction and reverse bias is applied to collector-base junction.

✓ The forward bias in the emitter-base junction causes electrons to move toward base. This constitutes emitter current,  $I_E$

# Transistor biasing

- The **base-emitter** (BE) junction is **forward biased**
- The **base-collector** (BC) junction is **reverse biased**.

$$I_E = I_B + I_C$$



### 3. TRANSISTOR CIRCUIT CONFIGURATION

● Basically three types of circuit connections for operating a transistor,

1. Common base (**CB**) configuration.
2. Common emitter (**CE**) configuration.
3. Common collector (**CC**) configuration.

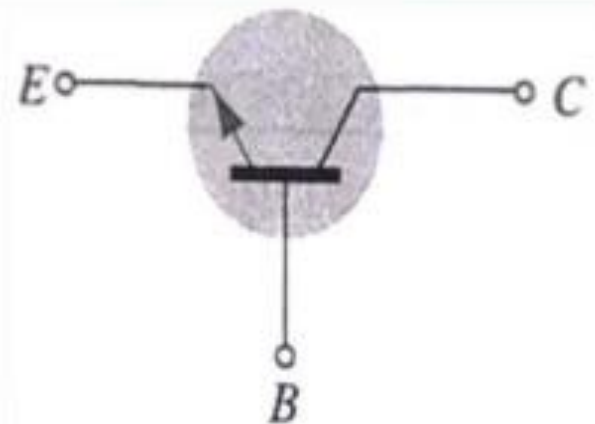
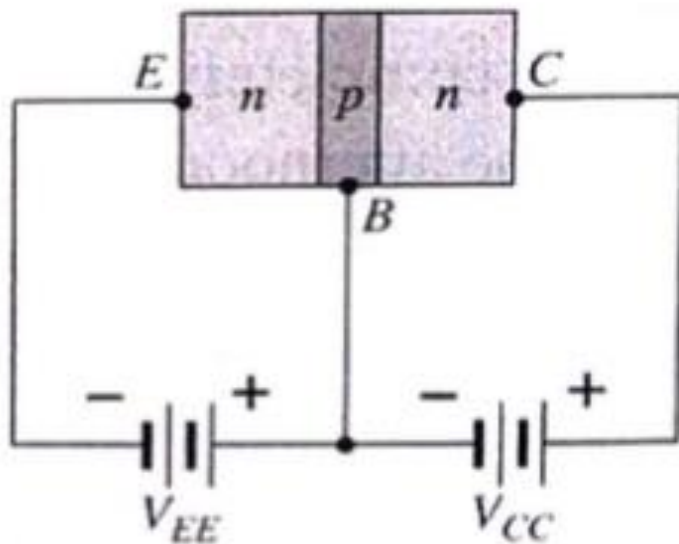
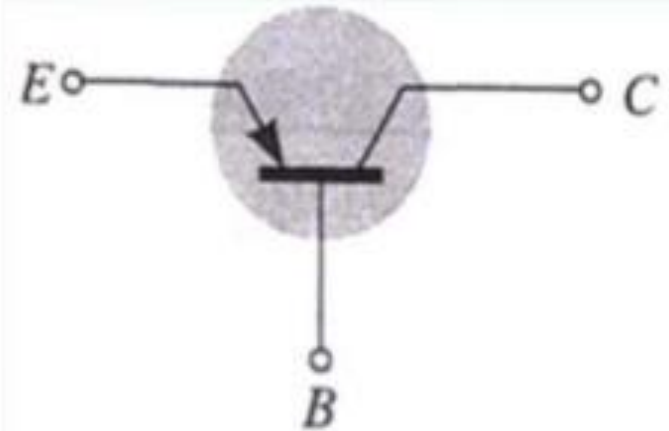
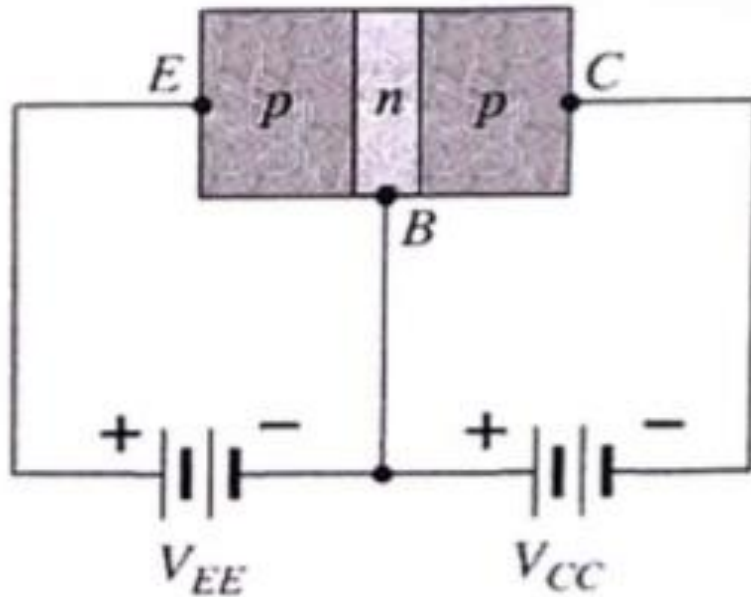
‘common’ denotes an electrode that is common to input and the output circuit, because the common electrode is generally grounded.



# Transistor Configurations

- Common-Base Configuration
- Common-Emitter Configuration
- Common-Collector Configuration

# Common-Base Configuration





- ✓ **Common Base Configuration:**
- ✓ In common base configuration, **emitter is the input terminal, collector is the output terminal** and **base terminal is connected as a common terminal for both input and output.**
- ✓ That means the **emitter terminal and common base terminal are known as input terminals** whereas the **collector terminal and common base terminal are known as output terminals.**
- ✓ In common base configuration, **the base terminal is grounded** so the common base configuration is also known as grounded base configuration.
- ✓ Sometimes **common base configuration is referred to as common base amplifier, CB amplifier, or CB configuration.**



# Common-Base Configuration

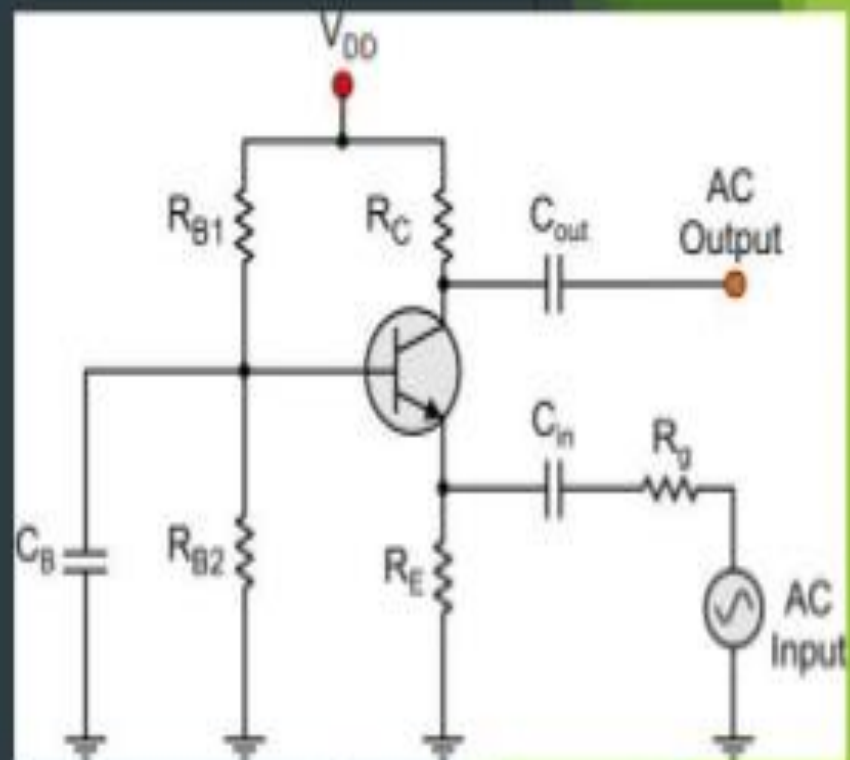
- The common-base configuration with *pnp* and *nnp* transistors are shown in the figures in the previous slide..
- The term *common-base* is derived from the fact that the base is common to both the input and output sides of the configuration.
- The arrow in the symbol defines the direction of emitter current through the device.
- The applied biasing are such as to establish current in the direction indicated for each branch.
- That is, direction of  $I_E$  is the same as the polarity of  $V_{EE}$  and  $I_C$  to  $V_{CC}$ .
- Also, the equation  $I_E = I_C + I_B$  still holds.

# Common-Base Configuration

- Common-base terminology is derived from the fact that the :
  - base is common to both input and output of the configuration.
  - base is usually the terminal closest to or at ground potential.
- All current directions will refer to **conventional** (hole) flow and the arrows in all electronic symbols have a direction defined by this convention.
- Note that the applied **biasing** (voltage sources) are such as to establish current in the direction indicated for each branch.

# Common base amplifier

- ▶ A **common base** also known as **grounded-base** amplifier is typically used as a voltage amplifier.
- ▶ In this circuit
  - The emitter terminal serves as the input
  - The collector as the output
  - The base is connected to ground, or "common".
- ▶ Features:
  - Low input impedance.
  - Moderate/High output impedance.
  - High Voltage Gain
  - Unity Current Gain.
  - Non-inverting amplifier.



The Common base amplifier circuit

## Circuit Arrangement For Input and Output Characteristic Curve in CB Configuration

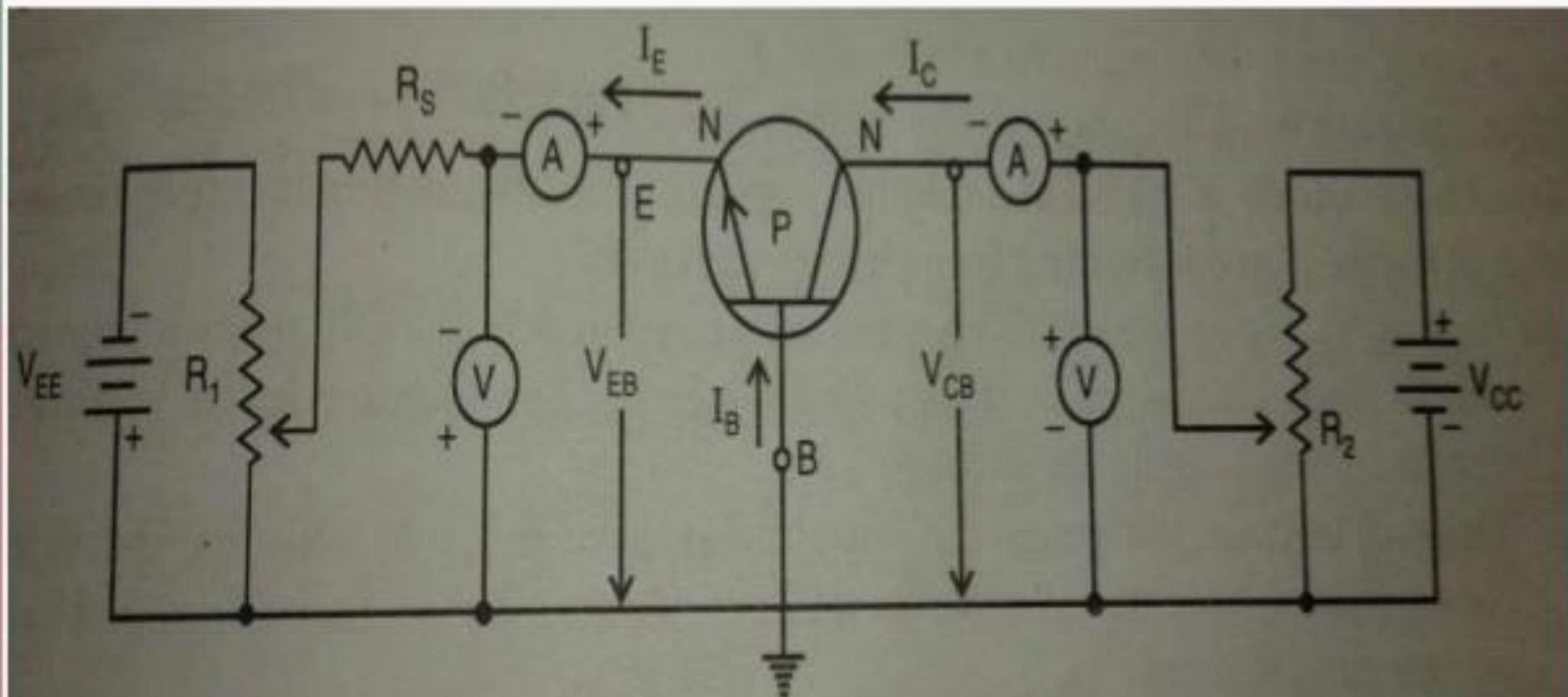


Fig. 5.26. Circuit arrangement for input and output characteristics curve in CB configuration

output. This difficulty is overcome by making one terminal of the transistor common to both input and output terminals. The input is fed between this common terminal and one of the other two terminals. The output is obtained between the common terminal and the remaining terminal. Accordingly; a transistor can be connected in a circuit in the following three ways :

- (i) common base connection
- (ii) common emitter connection
- (iii) common collector connection

Each circuit connection has specific advantages and disadvantages. It may be noted here that regardless of circuit connection, the emitter is always biased in the forward direction, while the collector always has a reverse bias.

## 11.8 Common Base Connection

In this circuit arrangement, input is applied between emitter and base and output is taken from collector and base. Here, base of the transistor is common to both input and output circuits and hence the name common base connection. In Fig. 11.9 (i), a common base *npn* transistor circuit is shown whereas Fig. 11.9 (ii) shows the common base *pnp* transistor circuit.

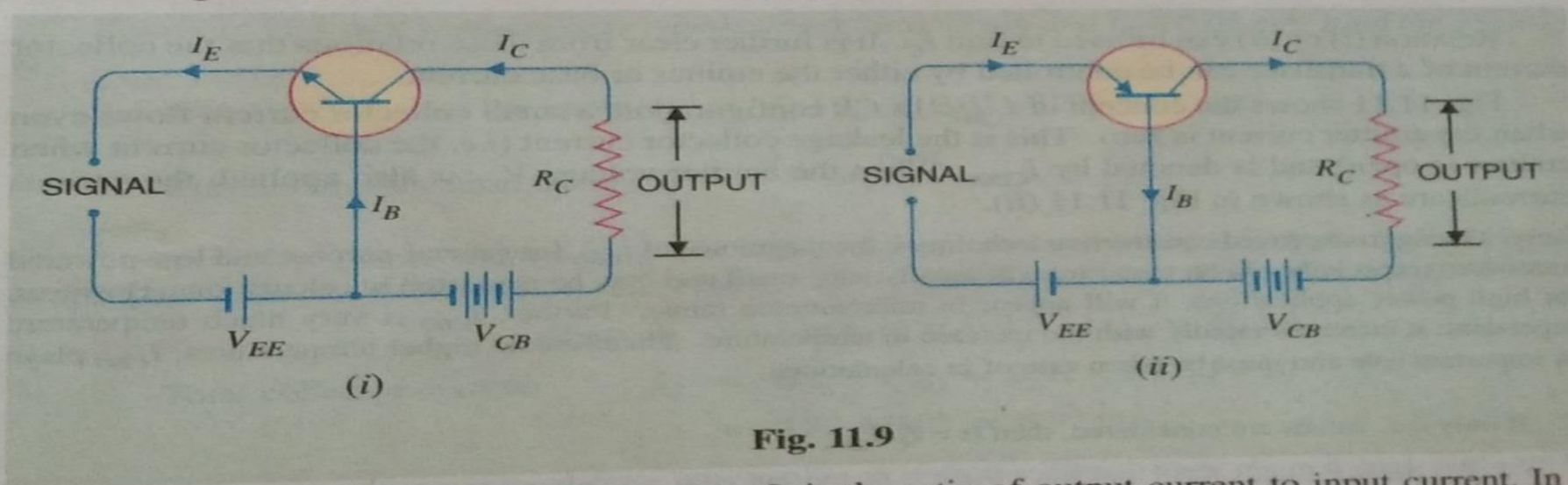


Fig. 11.9

**1. Current amplification factor ( $\alpha$ ).** It is the ratio of output current to input current. In a common base connection, the input current is the emitter current  $I_E$  and output current is the collector current  $I_C$ .

The ratio of change in collector current to the change in emitter current at constant collector-base voltage  $V_{CB}$  is known as **current amplification factor** i.e.

$$*\alpha = \frac{\Delta I_C}{\Delta I_E} \text{ at constant } V_{CB}$$

It is clear that current amplification factor is less than \*\*unity. This value can be increased (but not more than unity) by decreasing the base current. This is achieved by making the base thin and doping it lightly. Practical values of  $\alpha$  in commercial transistors range from 0.9 to 0.99.

**2. Expression for collector current.** The whole of emitter current does not reach the collector. It is because a small percentage of it, as a result of electron-hole combinations occurring in base area, gives rise to base current. Moreover, as the collector-base junction is reverse biased, therefore, some leakage current flows due to minority carriers. It follows, therefore, that total collector current consists of :

- (i) That part of emitter current which reaches the collector terminal *i.e.*  $***\alpha I_E$ .
- (ii) The leakage current  $I_{leakage}$ . This current is due to the movement of minority carriers across base-collector junction on account of it being reverse biased. This is generally much smaller than  $\alpha I_E$ .

$$\therefore \text{Total collector current, } I_C = \alpha I_E + I_{leakage}$$

It is clear that if  $I_E = 0$  (*i.e.*, emitter circuit is open), a small leakage current still flows in the collector circuit. This  $I_{leakage}$  is abbreviated as  $I_{CBO}$ , meaning collector-base current with emitter open. The  $I_{CBO}$  is indicated in Fig. 11.10.

$$\therefore I_C = \alpha I_E + I_{CBO} \quad \dots(i)$$

$$\text{Now } I_E = I_C + I_B$$

$$\therefore I_C = \alpha (I_C + I_B) + I_{CBO}$$

$$\text{or } I_C (1 - \alpha) = \alpha I_B + I_{CBO}$$

$$\text{or } I_C = \frac{\alpha}{1 - \alpha} I_B + \frac{I_{CBO}}{1 - \alpha} \quad \dots(ii)$$

Relation (i) or (ii) can be used to find  $I_C$ . It is further clear from these relations that the collector current of a transistor can be controlled by either the emitter or base current.

Fig. 11.11 shows the concept of  $I_{CBO}$ . In CB configuration, a small collector current flows even when the emitter current is zero. This is the leakage collector current (*i.e.* the collector current when emitter is open) and is denoted by  $I_{CBO}$ . When the emitter voltage  $V_{EE}$  is also applied, the various currents are as shown in Fig. 11.11 (ii).

**Note.** Owing to improved construction techniques, the magnitude of  $I_{CBO}$  for general-purpose and low-powered transistors (especially silicon transistors) is usually very small and may be neglected in calculations. However, for high power applications, it will appear in microampere range. Further,  $I_{CBO}$  is very much temperature dependent; it increases rapidly with the increase in temperature. Therefore, at higher temperatures,  $I_{CBO}$  plays an important role and must be taken care of in calculations.

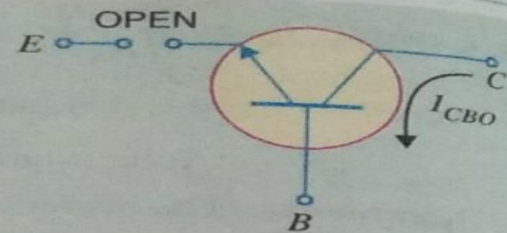


Fig. 11.10

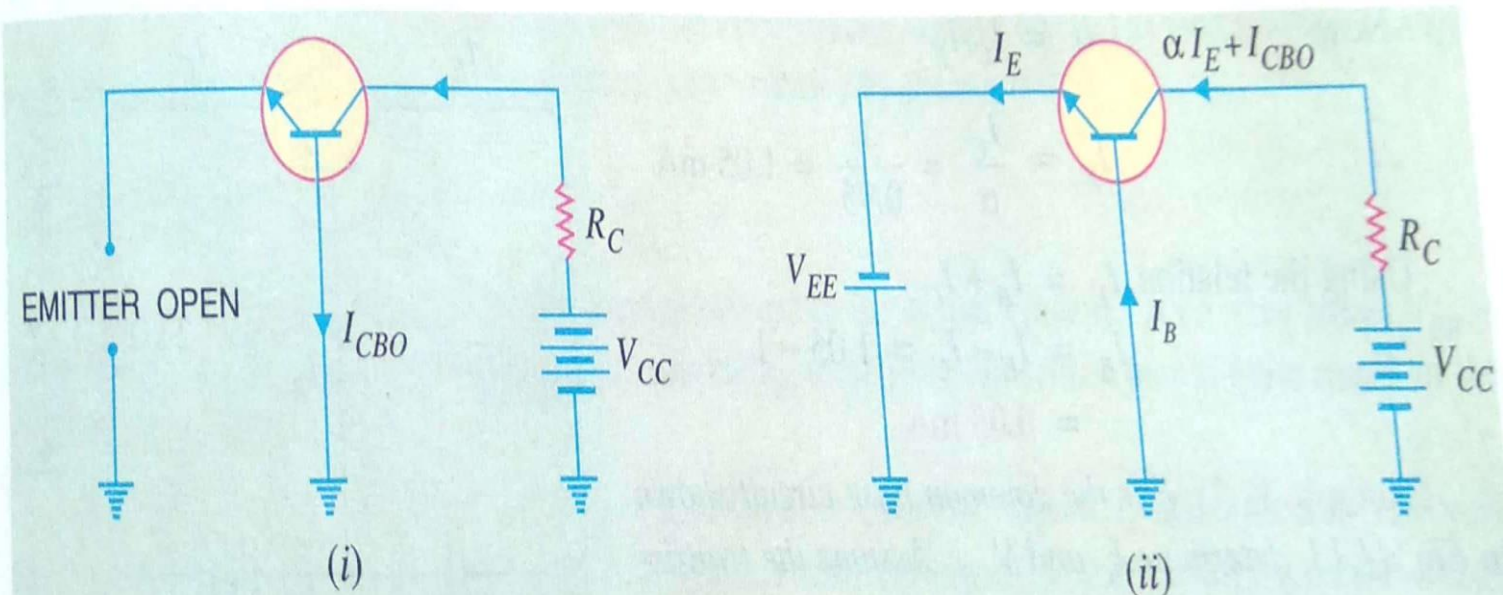


Fig. 11.11

**Example 11.2.** In a common base connection,  $I_E = 1\text{mA}$ ,  $I_C = 0.95\text{mA}$ . Calculate the value

**Solution.** Using the relation,  $I_E = I_B + I_C$



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# Transistor Characteristics in Common-Base Configuration

In common-base configuration 2 types of characteristics are :

## 1. Input Characteristics :

Curves relate the input or emitter current  $I_E$  and input or emitter-to-base voltage  $V_{EB}$  keeping output or collector-to-base voltage  $V_{CB}$  constant.

## 2. Output Characteristics :

Curves relate the output or collector current  $I_C$  and output or collector-to-base voltage  $V_{CB}$  keeping the input or emitter current  $I_E$  constant.

$$V_{EE} = I_E R_E + V_{BE}$$

or 
$$I_E = \frac{V_{EE} - V_{BE}}{R_E}$$

$$= \frac{8V - 0.7V}{1.5 \text{ k}\Omega} = 4.87 \text{ mA}$$

$$\therefore I_C \approx I_E = 4.87 \text{ mA}$$

Applying Kirchoff's voltage law to the collector-side loop, we have,

$$V_{CC} = I_C R_C + V_{CB}$$

$$\therefore V_{CB} = V_{CC} - I_C R_C = 18 \text{ V} - 4.87 \text{ mA} \times 1.2 \text{ k}\Omega = 12.16 \text{ V}$$

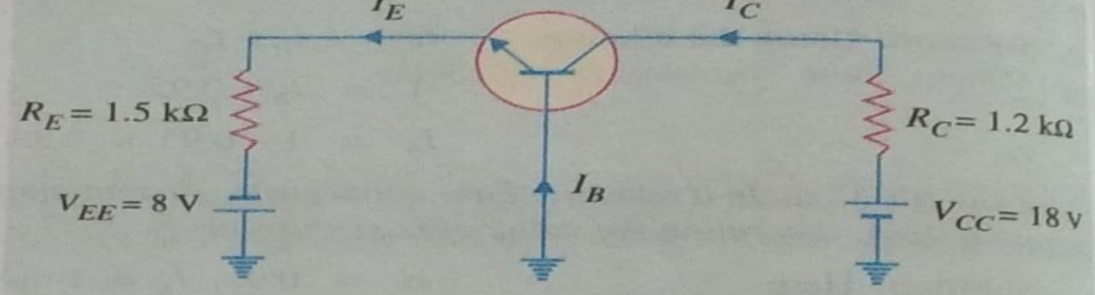


Fig. 11.13

### 11.9 Characteristics of Common Base Connection

The complete electrical behaviour of a transistor can be described by stating the interrelation of the various currents and voltages. These relationships can be conveniently displayed graphically and the curves thus obtained are known as the characteristics of transistor. The most important characteristics of common base connection are *input characteristics* and *output characteristics*.

**1. Input characteristic.** It is the curve between emitter current  $I_E$  and emitter-base voltage  $V_{EB}$  at constant collector-base voltage  $V_{CB}$ . The emitter current is generally taken along  $y$ -axis and emitter-base voltage along  $x$ -axis. Fig. 11.14 shows the input characteristics of a typical transistor in  $CB$  arrangement. The following points may be noted from these characteristics :

(i) The emitter current  $I_E$  increases rapidly with small increase in emitter-base voltage  $V_{EB}$ . It means that input resistance is very small.

(ii) The emitter current is almost independent of collector-base voltage  $V_{CB}$ . This leads to the conclusion that emitter current (and hence collector current) is almost independent of collector voltage.

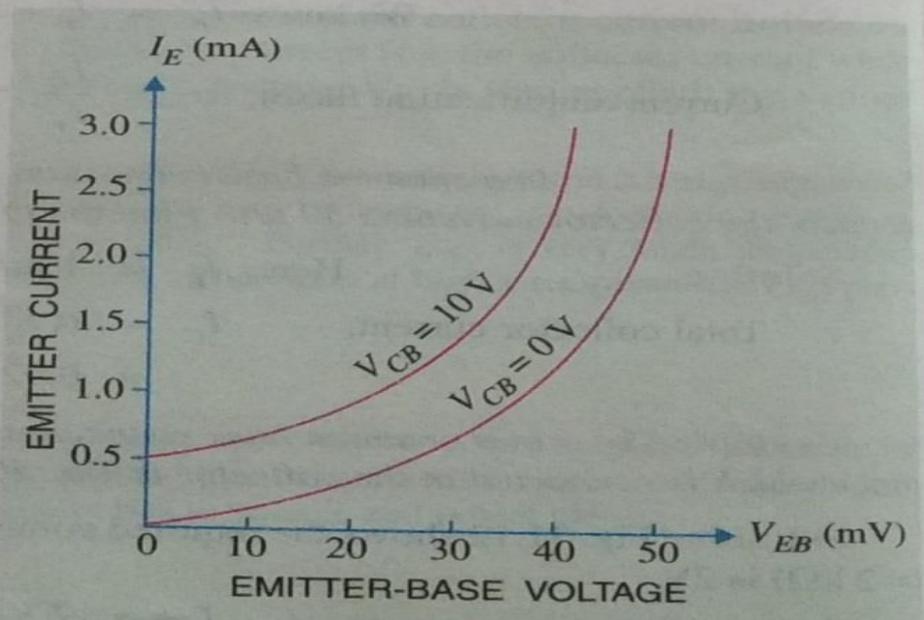


Fig. 11.14

**Input resistance.** It is the ratio of change in emitter-base voltage ( $\Delta V_{EB}$ ) to the resulting change in emitter current ( $\Delta I_E$ ) at constant collector-base voltage ( $V_{CB}$ ) i.e.

$$\text{Input resistance, } r_i = \frac{\Delta V_{BE}}{\Delta I_E} \text{ at constant } V_{CB}$$

In fact, input resistance is the opposition offered to the signal current. As a very small  $V_{EB}$  is sufficient to produce a large flow of emitter current  $I_E$ , therefore, input resistance is quite small, of the order of a few ohms.

**2. Output characteristic.** It is the curve between collector current  $I_C$  and collector-base voltage  $V_{CB}$  at constant emitter current  $I_E$ . Generally, collector current is taken along y-axis and collector-base voltage along x-axis. Fig. 11.15 shows the output characteristics of a typical transistor in *CB* arrangement.

The following points may be noted from the characteristics :

(i) The collector current  $I_C$  varies with  $V_{CB}$  only at very low voltages ( $< 1V$ ). The transistor is *never* operated in this region.

(ii) When the value of  $V_{CB}$  is raised above 1 – 2 V, the collector current becomes constant as indicated by straight horizontal curves. It means that now  $I_C$  is independent of  $V_{CB}$  and depends upon  $I_E$  only. This is consistent with the theory that the emitter current flows *almost* entirely to the collector terminal. The transistor is *always* operated in this region.

(iii) A very large change in collector-base voltage produces only a tiny change in collector current. This means that output resistance is very high.

**Output resistance.** It is the ratio of change in collector-base voltage ( $\Delta V_{CB}$ ) to the resulting change in collector current ( $\Delta I_C$ ) at constant emitter current i.e.

$$\text{Output resistance, } r_o = \frac{\Delta V_{CB}}{\Delta I_C} \text{ at constant } I_E$$

The output resistance of *CB* circuit is very high, of the order of several tens of kilo-ohms. This is not surprising because the collector current changes very slightly with the change in  $V_{CB}$ .

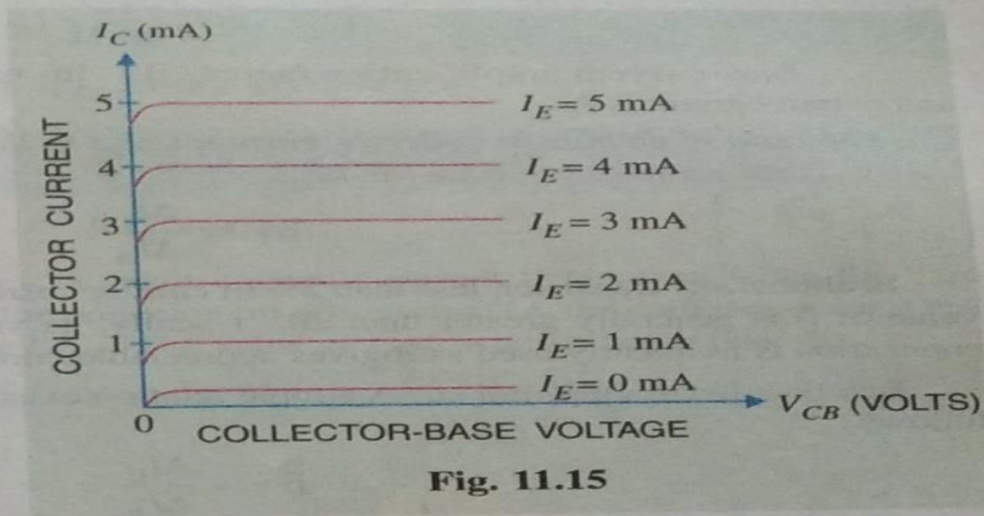


Fig. 11.15

## 11.10 Common Emitter Connection



# Output characteristics

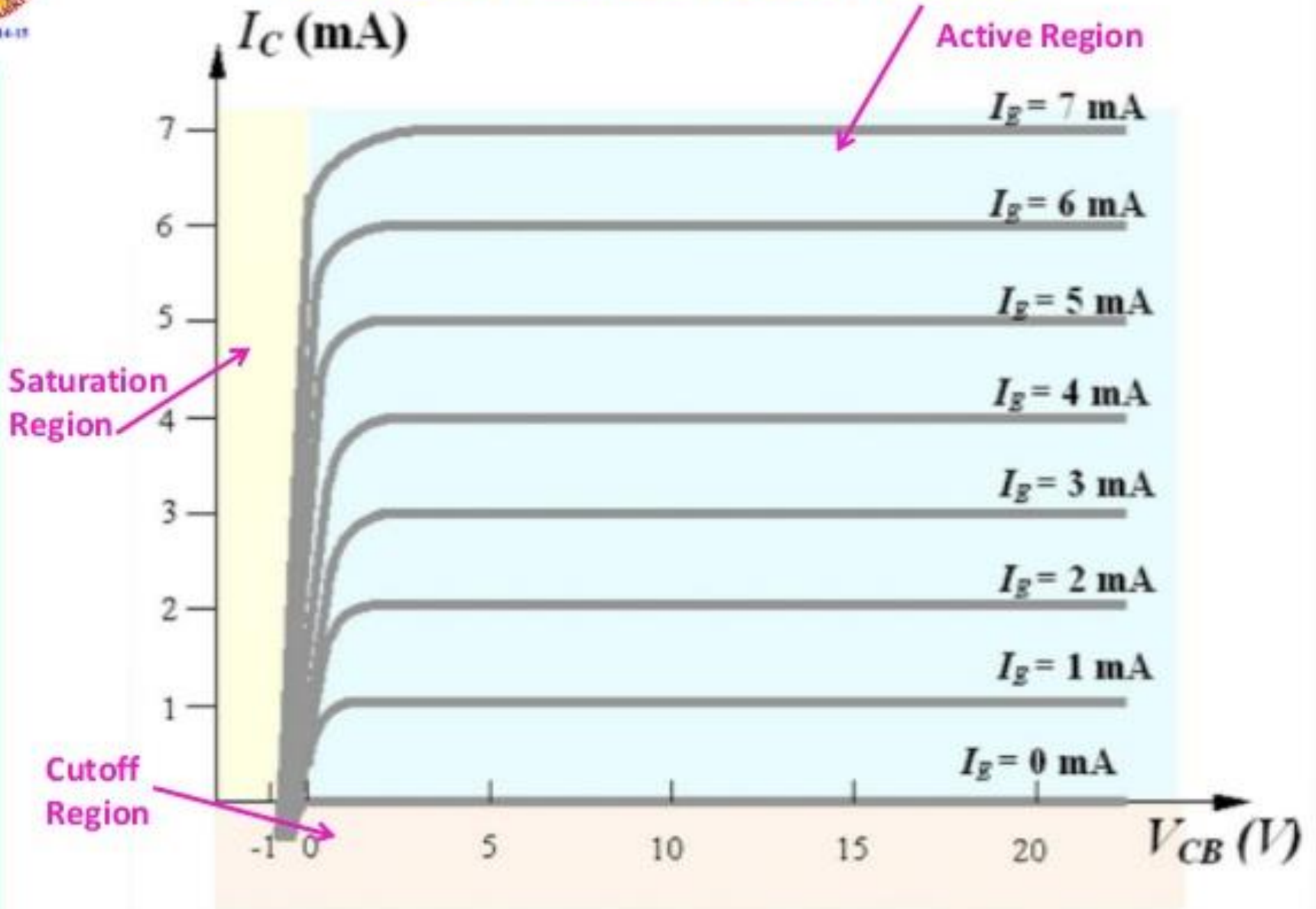
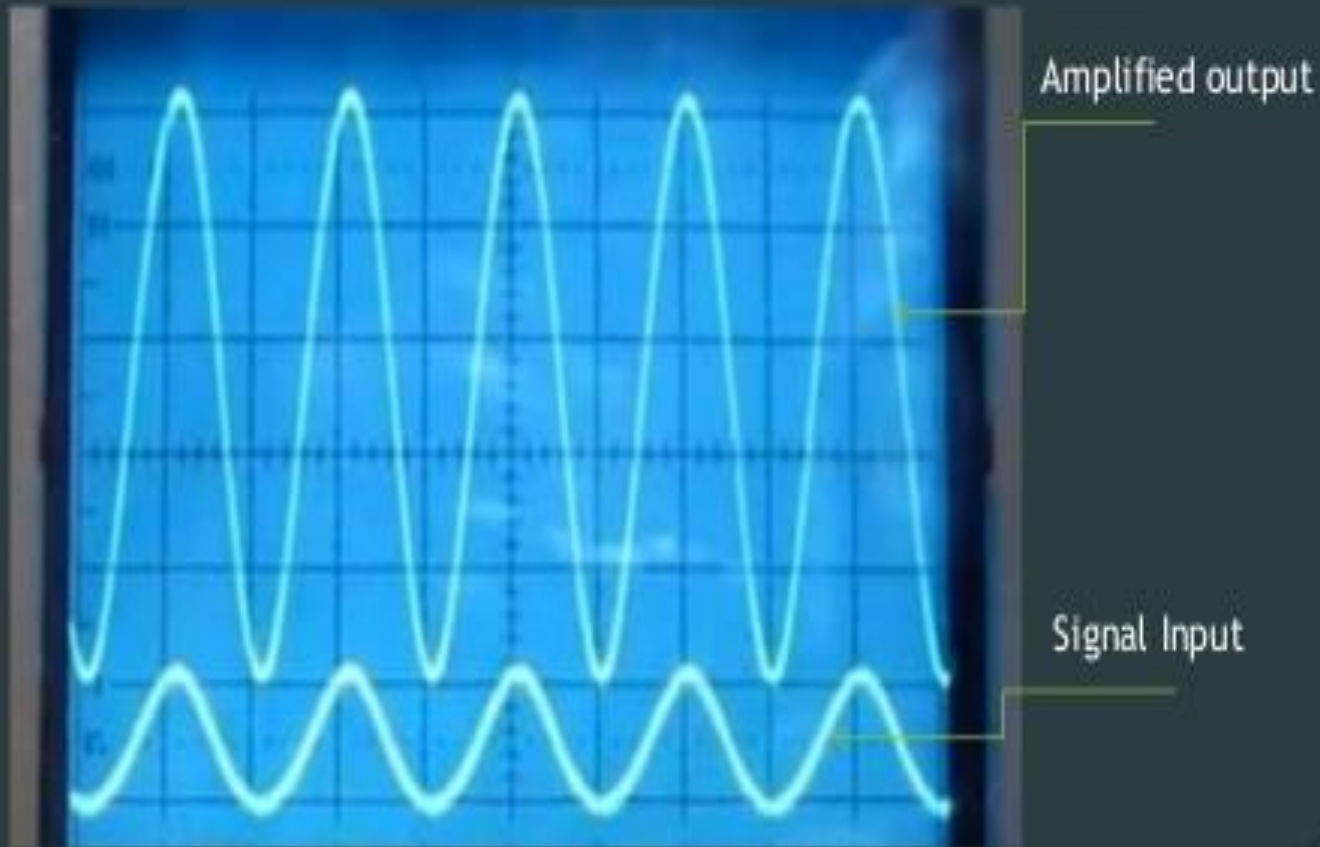


Figure: Output characteristics for common-base transistor

# Experimental Output of CB Amplifier





# common-emitter configurations

- Most common configuration of transistor is as shown
- *emitter* terminal is common to input and output circuits this is a **common-emitter** configuration
- we will look at the characteristics of the device in this configuration
- The current relations are still applicable, *i.e.*,
- $I_E = I_C + I_B$  and  $I_C = \alpha I_E$

The common-emitter configuration with *npn* and *pnp* transistors are shown in the figures.

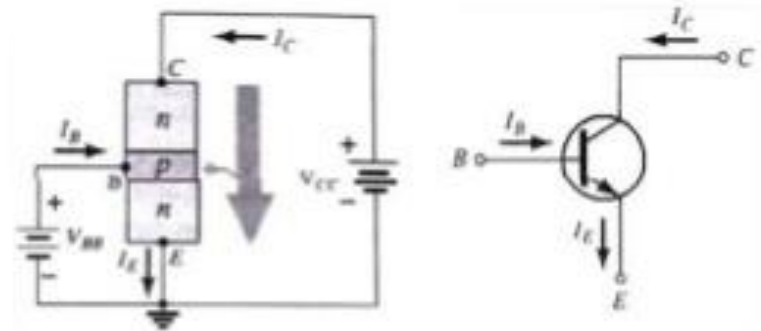


Figure: Common-emitter configuration of npn transistor

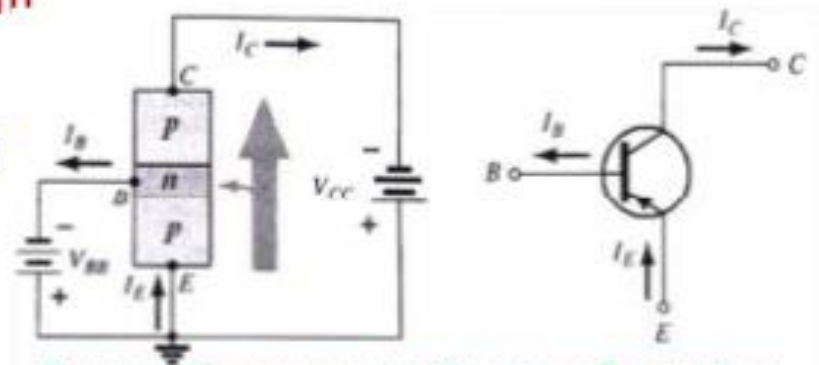


Figure: Common-emitter configuration of pnp transistor

## ❖ Common Emitter Configuration:

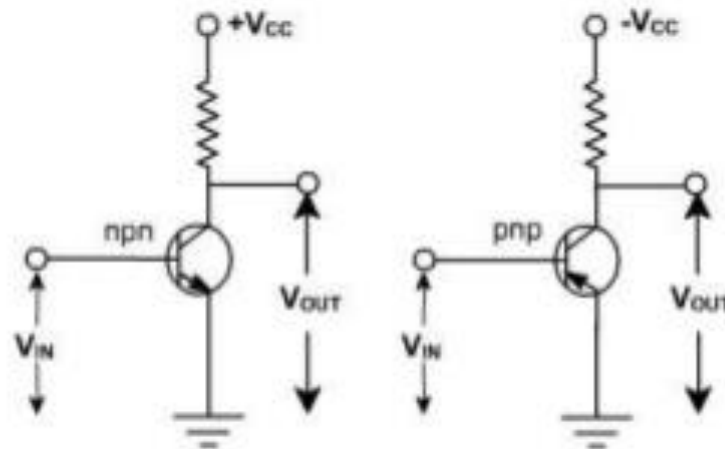
- ❖ *In common emitter configuration, base is the input terminal, collector is the output terminal and emitter is the common terminal for both input and output.*
- ❖ *That means the base terminal and common emitter terminal are known as input terminals whereas collector terminal and common emitter terminal are known as output terminals.*
- ❖ *In common emitter configuration, the emitter terminal is grounded so the common emitter configuration is also known as grounded emitter configuration.*
- ❖ *Sometimes common emitter configuration is also referred to as CE configuration, common emitter amplifier, or CE amplifier. The common emitter (CE) configuration is the most widely used transistor configuration.*

# Common emitter configuration

- Emitter is common for both input and output.
- It provides both current and voltage gain.
- Output has a phase shift of 180 degree with respect to input.

$$\beta = \frac{I_C}{I_B} \quad \alpha = \frac{I_C}{I_E}$$

$$\text{Voltage gain} = \frac{V_{out}}{V_{in}} = \frac{\Delta I_C}{\Delta V_B} = -\frac{R_L}{R_E}$$





# Common Emitter Amplifier

- ▶ a common emitter amplifier is typically used as a voltage amplifier
- ▶ Input is applied to base ,output is taken across collector and the emitter is grounded.
- ▶ Features:
  - Moderate /high input impedance.
  - Moderate output impedance.
  - High Voltage Gain
  - High Current Gain.
  - Output is Inverted

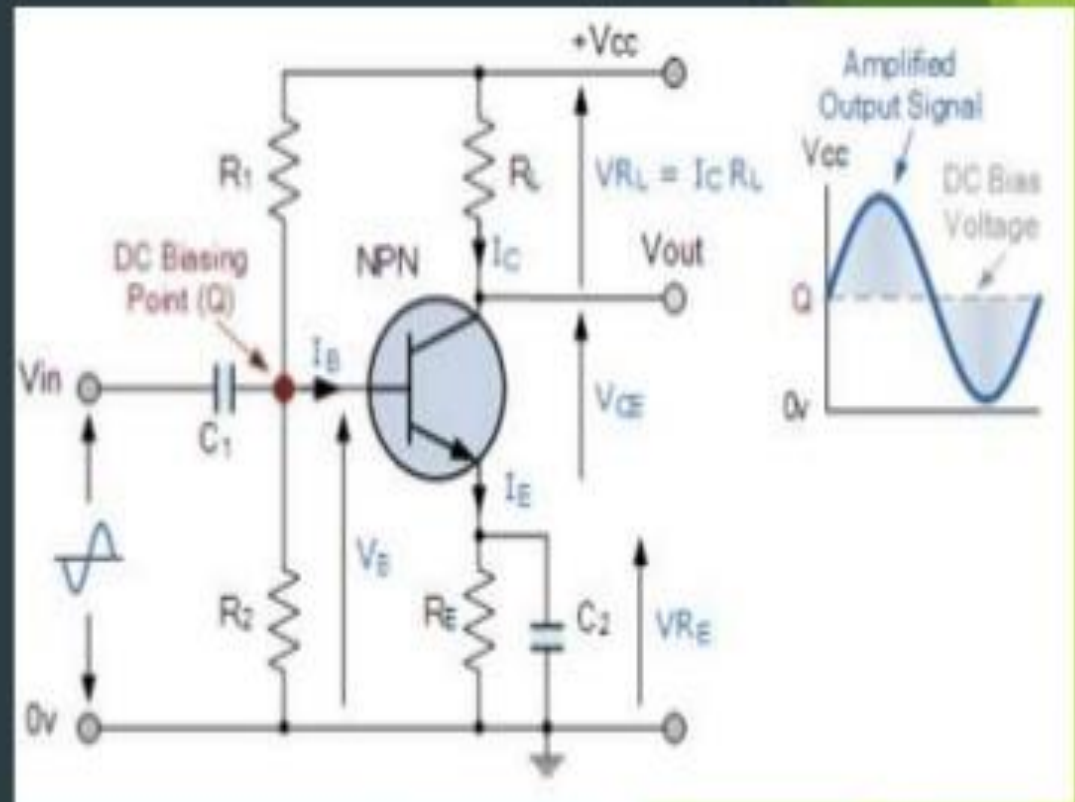


Fig. 11.16

**1. Base current amplification factor ( $\beta$ ).** In common emitter connection, input current is  $I_B$  and output current is  $I_C$

The ratio of change in collector current ( $\Delta I_C$ ) to the change in base current ( $\Delta I_B$ ) is known as **base current amplification factor** i.e.

$$\beta^* = \frac{\Delta I_C}{\Delta I_B}$$

In almost any transistor, less than 5% of emitter current flows as the base current. Therefore, the value of  $\beta$  is generally greater than 20. Usually, its value ranges from 20 to 500. This type of connection is frequently used as it gives appreciable current gain as well as voltage gain.

**Relation between  $\beta$  and  $\alpha$ .** A simple relation exists between  $\beta$  and  $\alpha$ . This can be derived as follows :

$$\beta = \frac{\Delta I_C}{\Delta I_B} \quad \dots(i)$$

$$\alpha = \frac{\Delta I_C}{\Delta I_E} \quad \dots(ii)$$

Now

$$I_E = I_B + I_C$$

or

$$\Delta I_E = \Delta I_B + \Delta I_C$$

or

$$\Delta I_B = \Delta I_E - \Delta I_C$$

Substituting the value of  $\Delta I_B$  in exp. (i), we get,

$$\beta = \frac{\Delta I_C}{\Delta I_E - \Delta I_C} \quad \dots(iii)$$

Dividing the numerator and denominator of R.H.S. of exp. (iii) by  $\Delta I_E$ , we get,

$$\beta = \frac{\Delta I_C / \Delta I_E}{\frac{\Delta I_E}{\Delta I_E} - \frac{\Delta I_C}{\Delta I_E}} = \frac{\alpha}{1 - \alpha} \quad \left[ \because \alpha = \frac{\Delta I_C}{\Delta I_E} \right]$$

$\therefore$

$$\beta = \frac{\alpha}{1 - \alpha}$$

It is clear that as  $\alpha$  approaches unity,  $\beta$  approaches infinity. In other words, the current gain in common emitter connection is very high. It is due to this reason that this circuit arrangement is used in about 90 to 95 percent of all transistor applications.

\* If d.c. values are considered,  $\beta = I_C / I_B$ .

2. **Expression for collector current.** In common emitter circuit,  $I_B$  is the input current and  $I_C$  is the output current.

We know  $I_E = I_B + I_C$  ... (i)

and  $I_C = \alpha I_E + I_{CBO}$  ... (ii)

From exp. (ii), we get,  $I_C = \alpha I_E + I_{CBO} = \alpha (I_B + I_C) + I_{CBO}$

or  $I_C (1 - \alpha) = \alpha I_B + I_{CBO}$

or  $I_C = \frac{\alpha}{1 - \alpha} I_B + \frac{1}{1 - \alpha} I_{CBO}$  ... (iii)

From exp. (iii), it is apparent that if  $I_B = 0$  (i.e. base circuit is open), the collector current will be the current to the emitter. This is abbreviated as  $I_{CEO}$ , meaning collector-emitter current with base open.

$\therefore I_{CEO} = \frac{1}{1 - \alpha} I_{CBO}$

Substituting the value of  $\frac{1}{1 - \alpha} I_{CBO} = I_{CEO}$  in exp. (iii), we get,

$I_C = \frac{\alpha}{1 - \alpha} I_B + I_{CEO}$

or  $I_C = \beta I_B + I_{CEO}$  ( $\because \beta = \frac{\alpha}{1 - \alpha}$ )

**Concept of  $I_{CEO}$ :** In CE configuration, a small collector current flows even when the base current is zero [See Fig: 11.17 (i)]. This is the collector cut off current (i.e. the collector current that flows when base is open) and is denoted by  $I_{CEO}$ . The value of  $I_{CEO}$  is much larger than  $I_{CBO}$ .

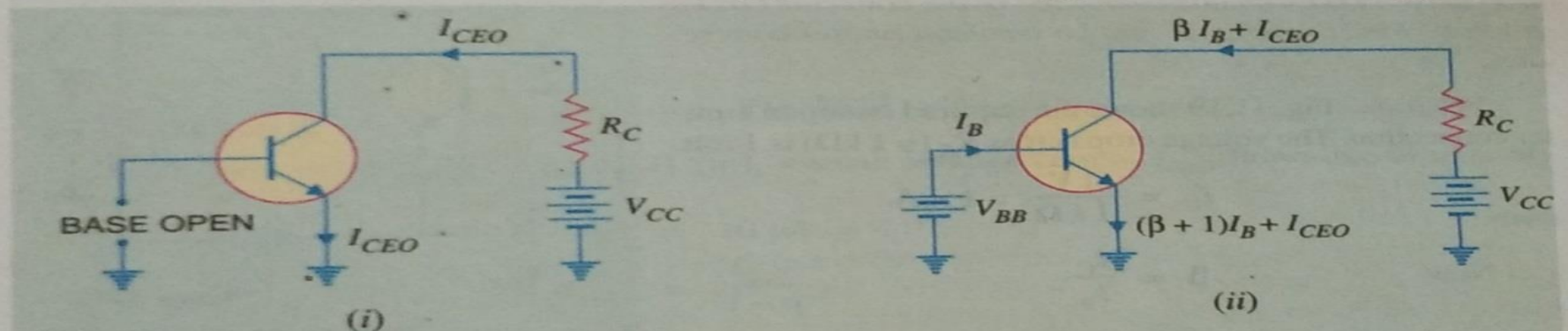


Fig. 11.17

When the base voltage is applied as shown in Fig. 11.17 (ii), then the various currents are :

- Base current =  $I_B$
- Collector current =  $\beta I_B + I_{CEO}$
- Emitter current = Collector current + Base current



# Input characteristics

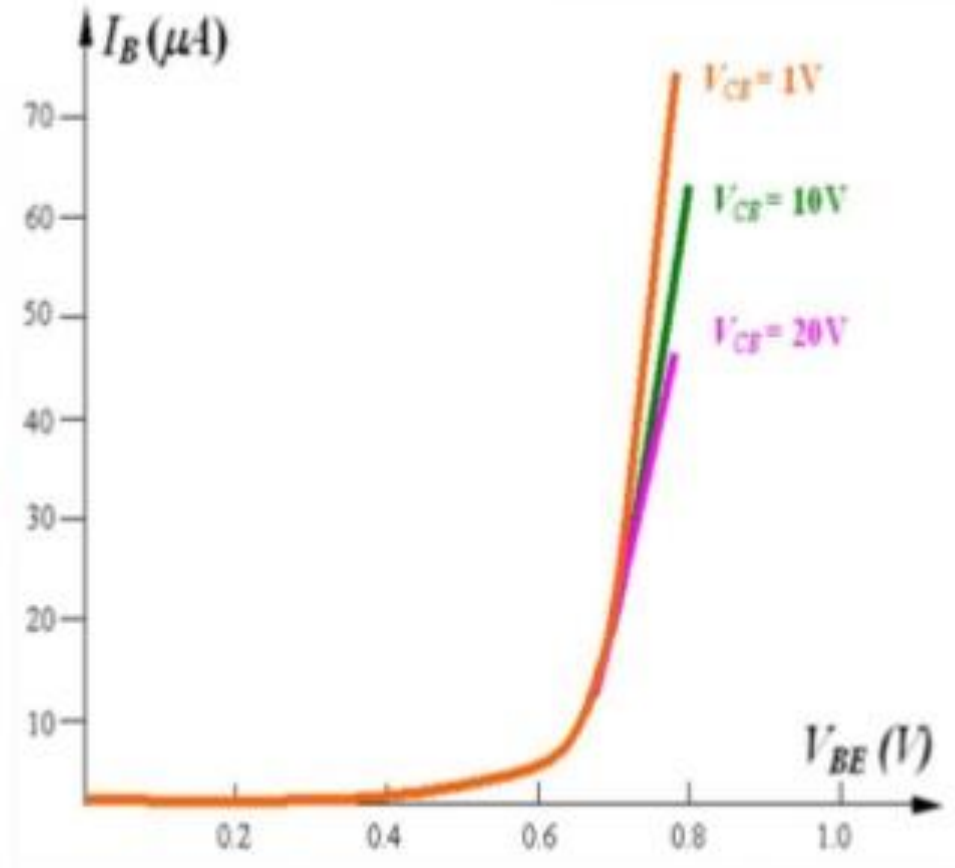
It is a curve which shows the relationship between the base current,  $I_B$  and the collector base voltage  $V_{CB}$  at constant  $V_{CE}$ . This method of determining the characteristic is as follows.

- First, a suitable voltage is applied between the emitter and the collector.
- Next the input voltage  $V_{CB}$  is increased in a number of steps and corresponding values of  $I_E$  are noted.
- The base current is taken on the y-axis, and the input voltage is taken on the x-axis. Fig. shows the family of the input characteristic at different collector- emitter voltages.



# Input characteristics

- the input takes the form of a forward-biased  $pn$  junction
- the input characteristics are therefore similar to those of a semiconductor diode



An input current ( $I_B$ ) is a function of an input voltage ( $V_{BE}$ ) for various of output voltage ( $V_{CE}$ ).



# Output characteristics

Active Region

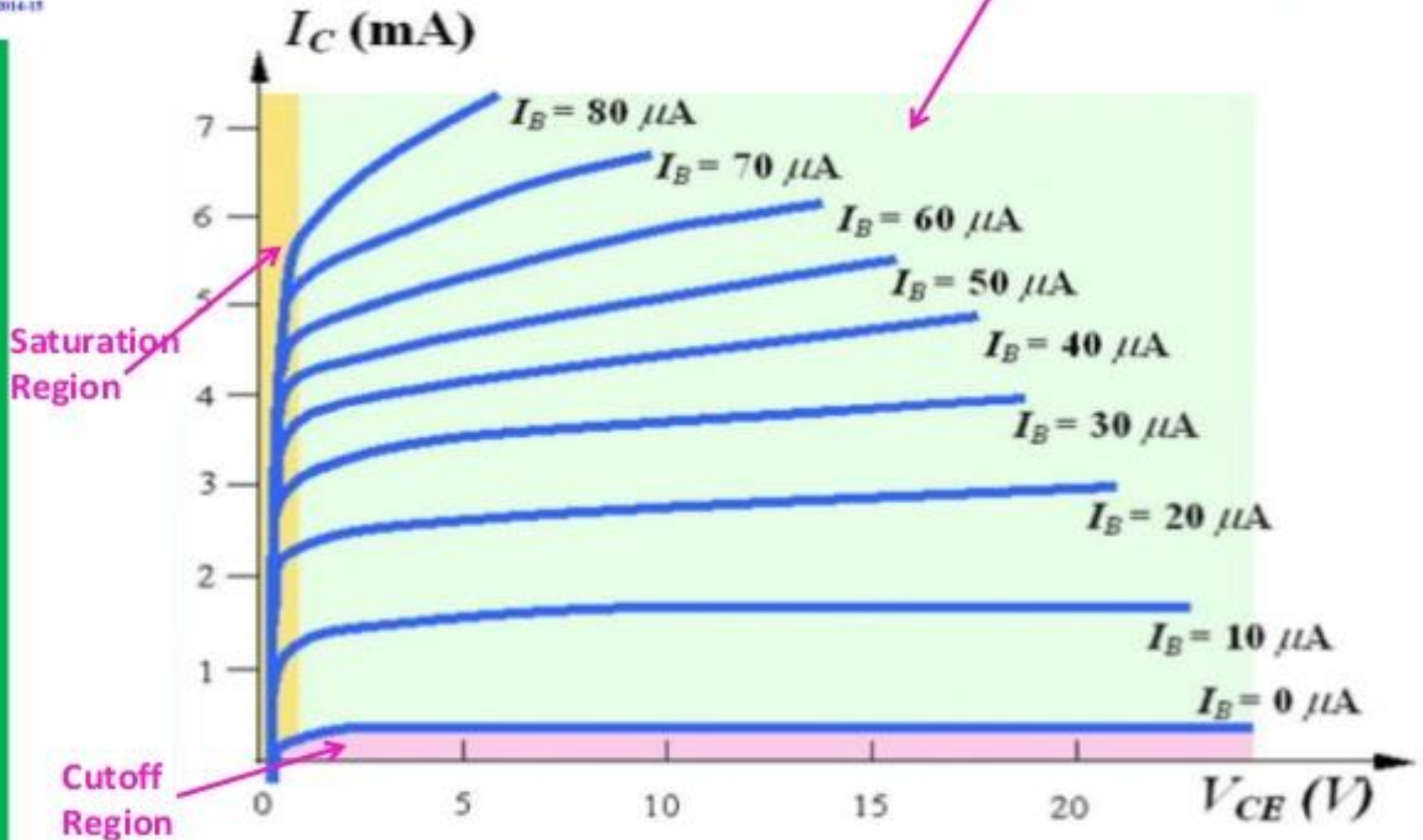
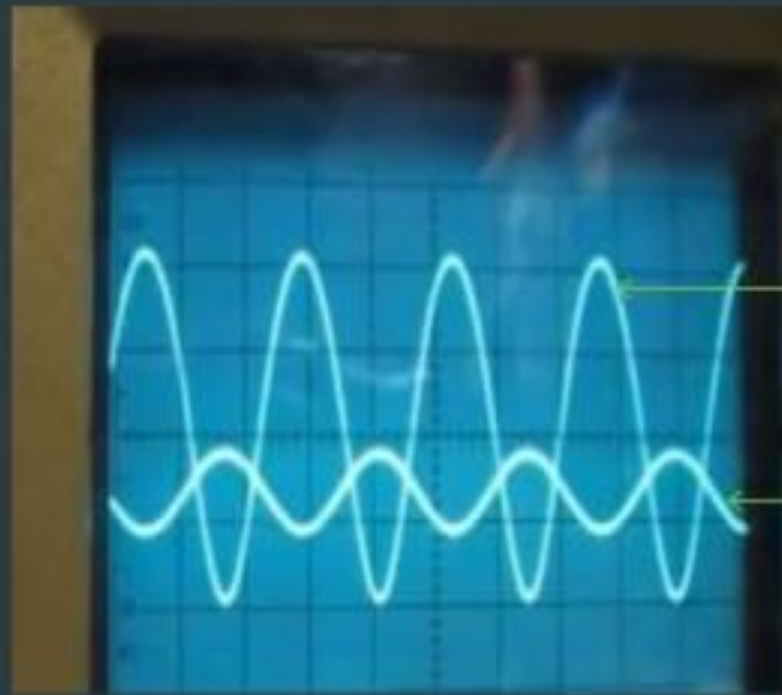


Figure: Output characteristics for common-emitter transistor

## Experimental Output of CE



Amplified output

Signal Input

# Common-Collector Configuration

- The common-collector configuration with *npn* and *pnp* transistors are shown in the figures.

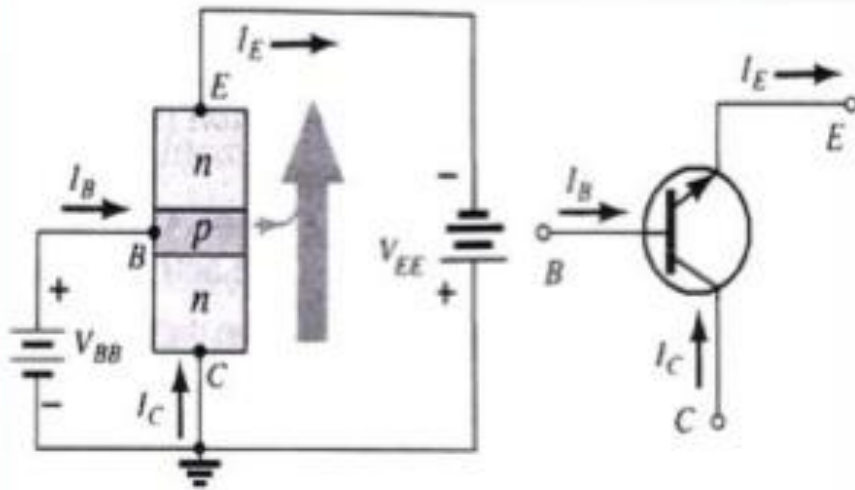


Figure: Common-collector configuration of *npn* transistor

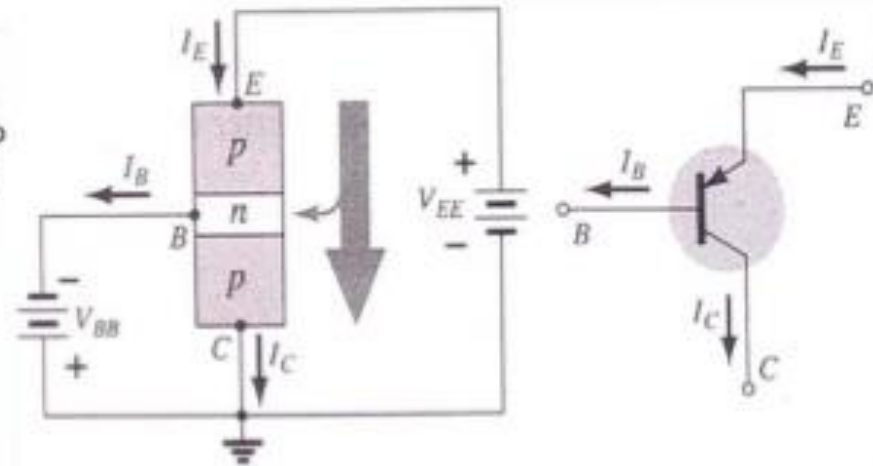


Figure: Common-collector configuration of *pnp* transistor



**Output resistance.** It is the ratio of change in collector-emitter voltage ( $\Delta V_{CE}$ ) to the change in collector current ( $\Delta I_C$ ) at constant  $I_B$  i.e.

$$\text{Output resistance, } r_o = \frac{\Delta V_{CE}}{\Delta I_C} \text{ at constant } I_B$$

It may be noted that whereas the output characteristics of *CB* circuit are horizontal, they have noticeable slope for the *CE* circuit. Therefore, the output resistance of a *CE* circuit is less than that of *CB* circuit. Its value is of the order of 50 k $\Omega$ .

### 11.12 Common Collector Connection

In this circuit arrangement, input is applied between base and collector while output is taken between the emitter and collector. Here, collector of the transistor is common to both input and output circuits and hence the name common collector connection. Fig. 11.25 (i) shows common collector *npn* transistor circuit whereas Fig. 11.25 (ii) shows common collector *pnp* circuit.

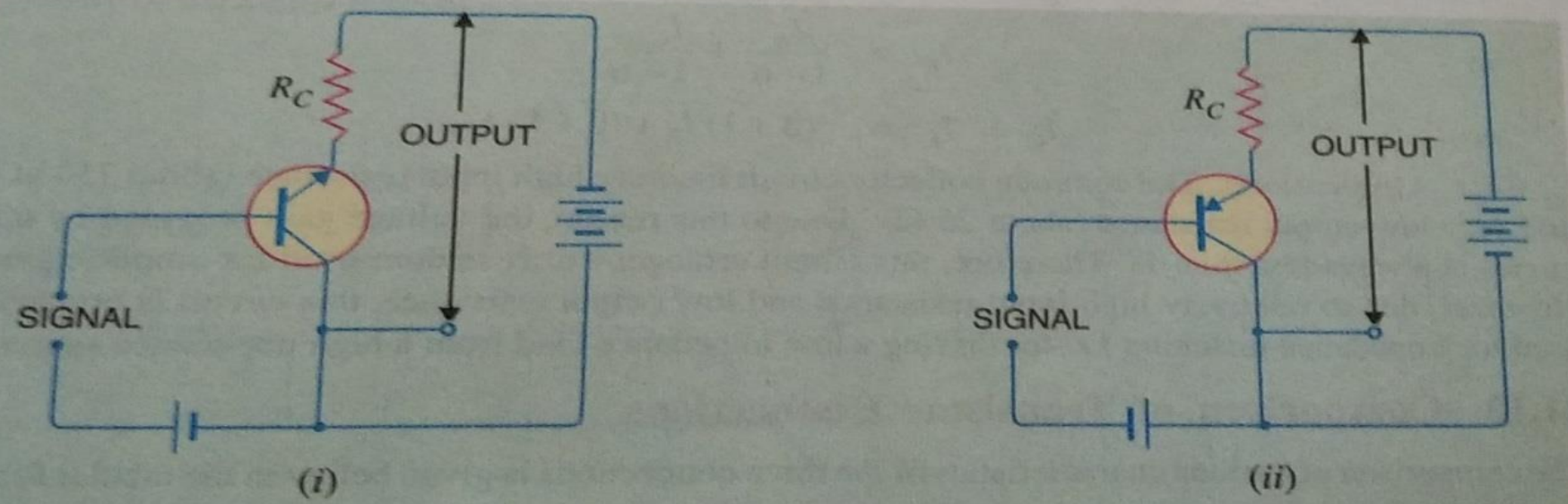


Fig. 11.25

**(i) Current amplification factor  $\gamma$ .** In common collector circuit, input current is the base current  $I_B$  and output current is the emitter current  $I_E$ . Therefore, current amplification in this circuit

- ✓ **Common Collector Configuration:**
- ✓ In this configuration, the **base terminal** of the **transistor** serves as **the input**, the **emitter terminal is the output** and the **collector terminal is common for both input and output**.
- ✓ Hence, it is named as **common collector configuration**.
- ✓ The **input is applied between the base and collector** while the **output is taken from the emitter and collector**.

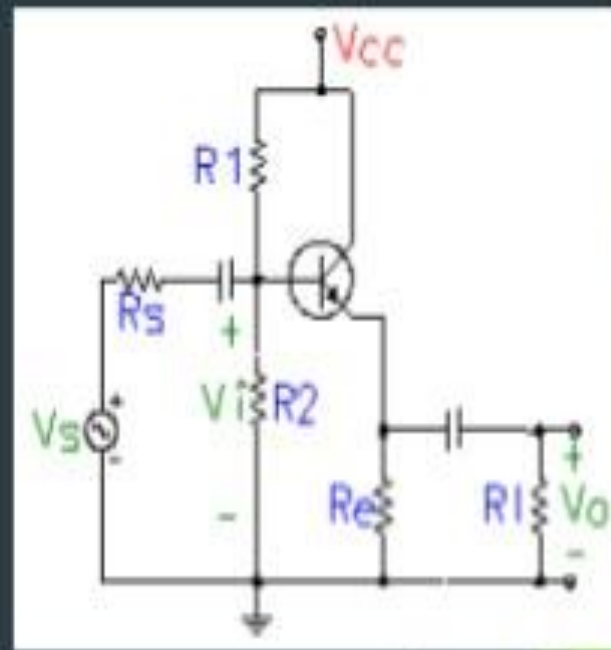


# Common-Collector Configuration

- It is used primarily for impedance-matching purpose since it has a high input impedance and low output impedance.
- The load resistor can be connected from emitter to ground.
- The collector is tied to ground and the circuit resembles common-emitter circuit.
- The output set relates an output current ( $I_E$ ) to an output voltage ( $V_{CE}$ ) for various of level of input current ( $I_B$ ).

# Common collector

- ▶ Common collector amplifier also known as an **emitter follower** typically used as a voltage buffer.
- ▶ In this circuit
  - The base terminal serves as the input,
  - The emitter is the output
  - The collector is common.
- ▶ Features:
  - Moderate/high input impedance.
  - Low output impedance.
  - Low (unity) voltage gain.
  - High Current Gain.



The CC amplifier circuit

# Common collector configuration

- In this collector terminal is common for both input and output.
- It provides high current gain.

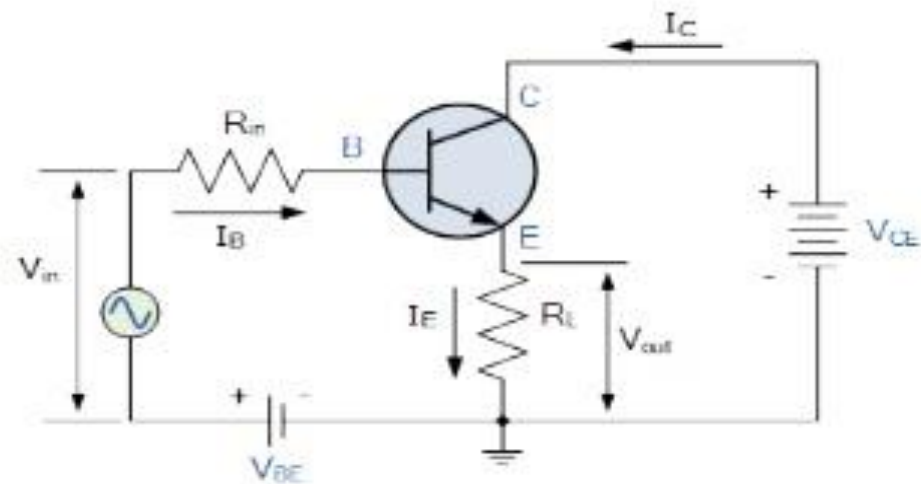
$$A_i = \frac{\text{output current}}{\text{input current}}$$

$$A_i = \frac{I_E}{I_B}$$

$$A_i = \frac{I_C}{I_B} + 1$$

$$\beta = \frac{I_C}{I_B}$$

$$A_i = \beta + 1$$



arrangement can be defined as under :

The ratio of change in emitter current ( $\Delta I_E$ ) to the change in base current ( $\Delta I_B$ ) is known as **current amplification factor** in common collector (CC) arrangement i.e.

$$\gamma = \frac{\Delta I_E}{\Delta I_B}$$

This circuit provides about the same current gain as the common emitter circuit as  $\Delta I_E \approx \Delta I_C$ . However, its voltage gain is always less than 1.

### Relation between $\gamma$ and $\alpha$

$$\gamma = \frac{\Delta I_E}{\Delta I_B} \quad \dots(i)$$

$$\alpha = \frac{\Delta I_C}{\Delta I_E} \quad \dots(ii)$$

Now

$$I_E = I_B + I_C$$

or

$$\Delta I_E = \Delta I_B + \Delta I_C$$

or

$$\Delta I_B = \Delta I_E - \Delta I_C$$

Substituting the value of  $\Delta I_B$  in exp. (i), we get,

$$\gamma = \frac{\Delta I_E}{\Delta I_E - \Delta I_C}$$

Dividing the numerator and denominator of R.H.S. by  $\Delta I_E$ , we get,

$$\gamma = \frac{\frac{\Delta I_E}{\Delta I_E}}{\frac{\Delta I_E}{\Delta I_E} - \frac{\Delta I_C}{\Delta I_E}} = \frac{1}{1 - \alpha} \quad \left( \because \alpha = \frac{\Delta I_C}{\Delta I_E} \right)$$

$\therefore$

$$\gamma = \frac{1}{1 - \alpha}$$

### (ii) Expression for collector current

We know

$$I_C = \alpha I_E + I_{CBO} \quad (\text{See Art. 11.8})$$

Also

$$I_E = I_B + I_C = I_B + (\alpha I_E + I_{CBO})$$

$\therefore$

$$I_E (1 - \alpha) = I_B + I_{CBO}$$

or

$$I_E = \frac{I_B}{1 - \alpha} + \frac{I_{CBO}}{1 - \alpha}$$

or

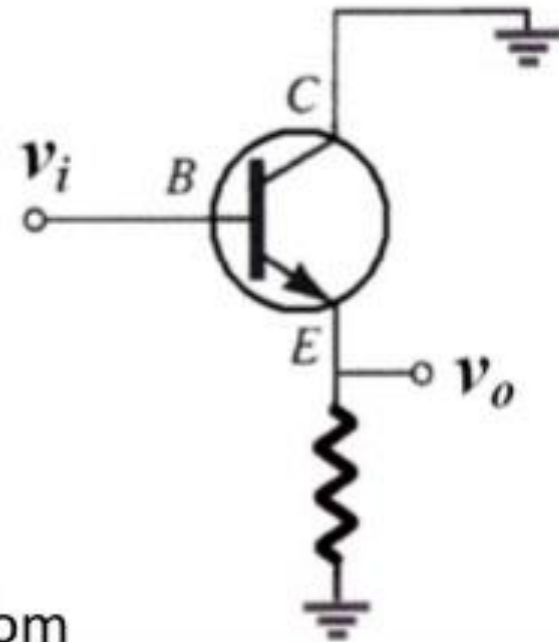
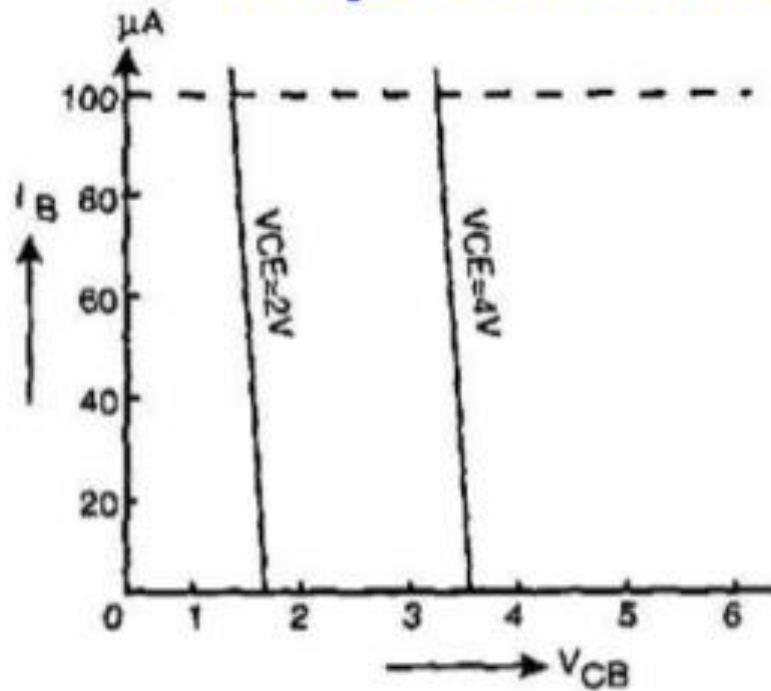
$$I_C \approx I_E = *(\beta + 1) I_B + (\beta + 1) I_{CBO}$$



# Input characteristics

- It is a curve which shows the relationship between the base current,  $I_B$  and the collector base voltage  $V_{CB}$  at constant  $V_{CE}$ . This method of determining the characteristic is as follows.
- First, a suitable voltage is applied between the emitter and the collector.
- Next the input voltage  $V_{CB}$  is increased in a number of steps and corresponding values of  $I_E$  are noted.
- The base current is taken on the y-axis, and the input voltage is taken on the x-axis. Fig. shows the family of the input characteristic at different collector- emitter voltages.

# Input characteristics



- The following points may be noted from the family of characteristic curves.
- Its characteristic is quite different from those of common base and common emitter circuits.
- When  $V_{CB}$  increases,  $I_B$  is decreased.

Figure: Common-collector circuit used for impedance-matching purpose



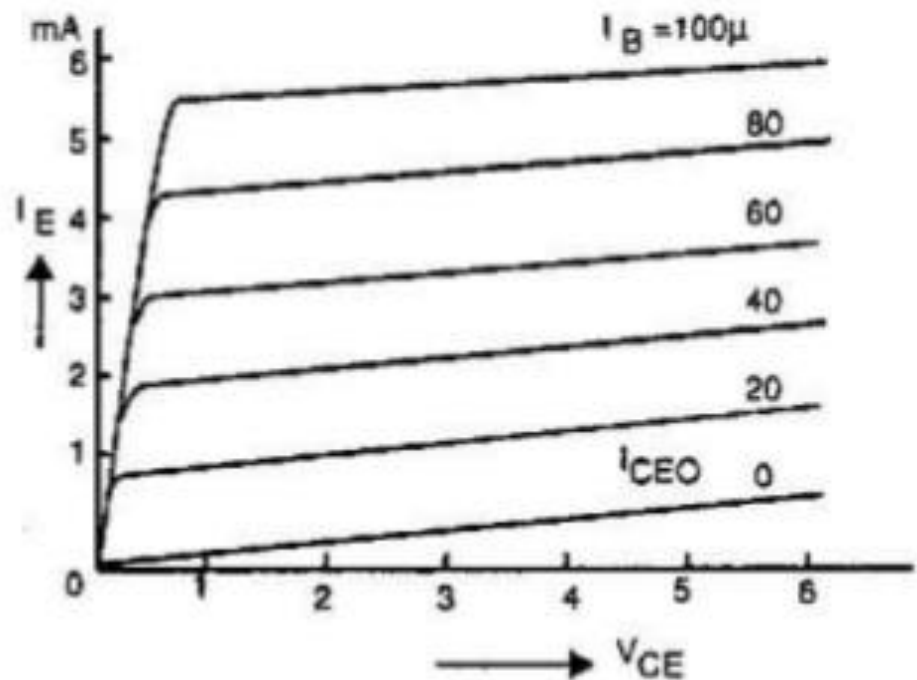


# Output characteristics

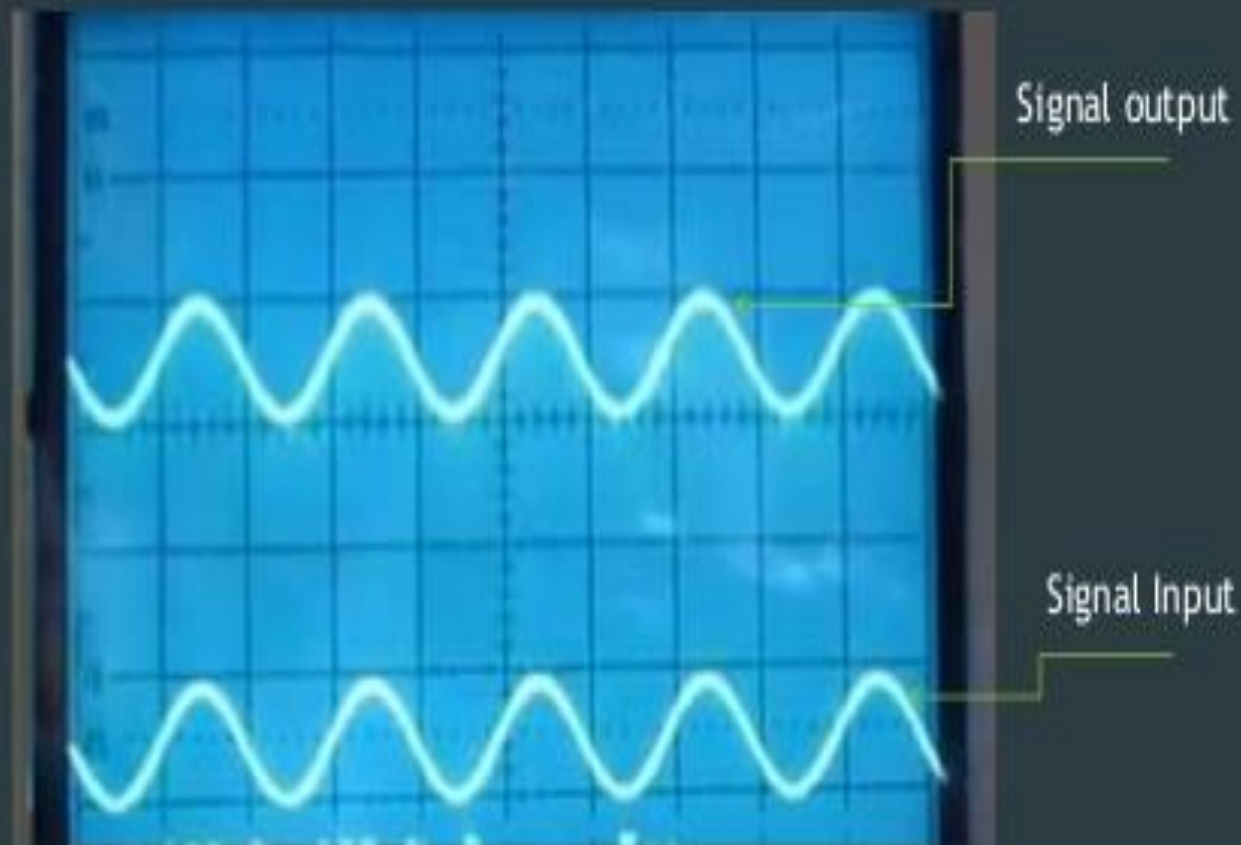
- This is almost the same as the output characteristics of common-emitter circuit, which are the relations between  $I_C$  and  $V_{CE}$  for various of level of input current  $I_B$ .

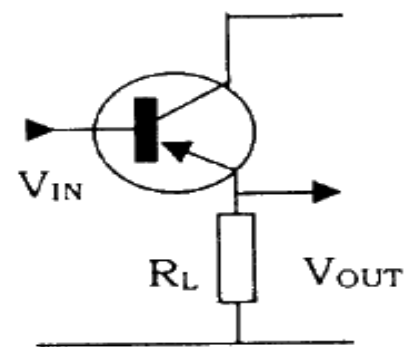
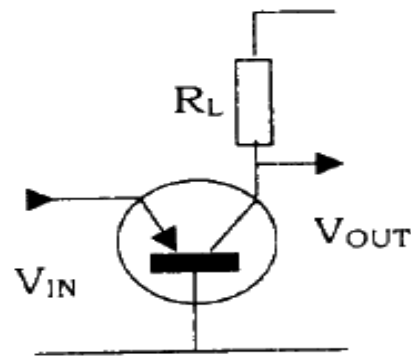
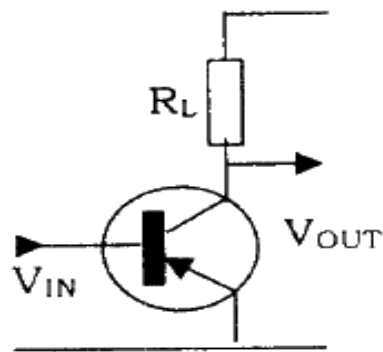
Since that:  $I_E \cong I_C$ .

Figure: Output characteristics for common-collector transistor



# Experimental Output of CC Amplifier.





	COMMON EMITTER	COMMON BASE	COMMON COLLECTOR
CURRENT GAIN	20 to 200	$< 1$ (0.95 to 0.995)	20 to 200
VOLTAGE GAIN	100 to 600	500 to 800	$< 1$
POWER GAIN	High	Medium	Low
INPUT IMPEDANCE	500 to 2000 $\Omega$	50 to 200 $\Omega$	20k $\Omega$ to 100k $\Omega$
OUTPUT IMPEDANCE	10k $\Omega$ to 50k $\Omega$	100k $\Omega$ to 1M $\Omega$	2 $\Omega$ to 500 $\Omega$
INPUT-OUTPUT PHASE RELATIONSHIP	180° out of phase	In phase	In phase
TYPICAL USE	Normal amplifier	Impedance matching (low to high)	Impedance matching (high to low)



**Thank You**